

Lecture Materials Characterization III

Winter term 2019/20

Part 2 (L. Grill)

Contact

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Physikalische Chemie

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Universität Graz

VL	
15.1.	17:00 - 18:30
20.1.	14:00 - 15:30
21.1.	14:00 - 15:30
27.1.	14:00 - 15:30
28.1.	14:00 - 15:30

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1.2 Field ion microscopy

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2.3 Auger spectroscopy

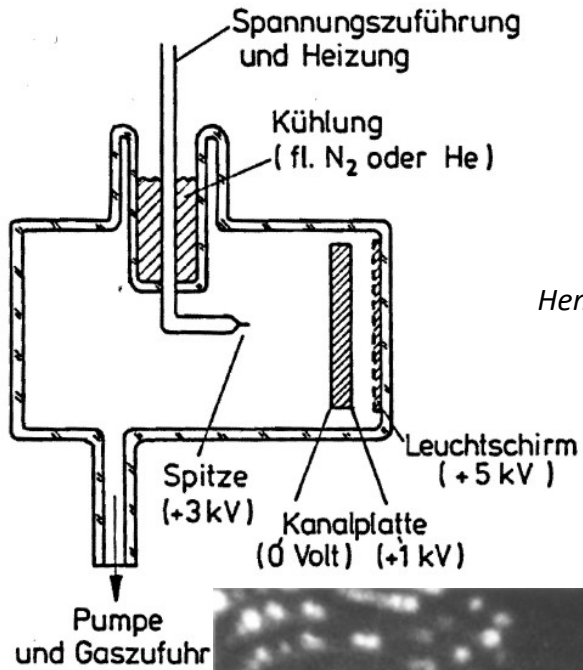
2.4 Photoelectron spectroscopy

2.5 Electron spectroscopy

2.6 Mass spectroscopy

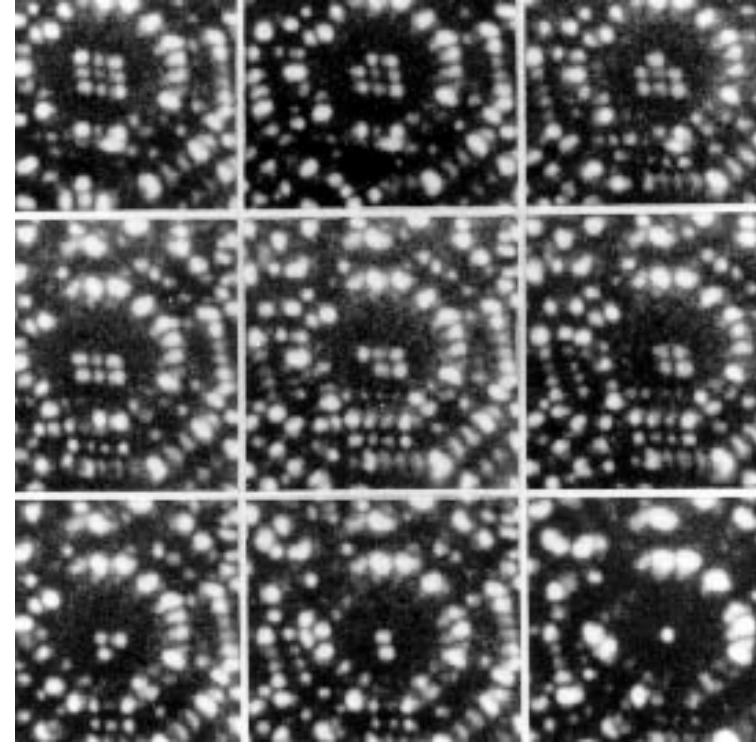
2.7 Secondary ion mass spectroscopy

Field ion microscope

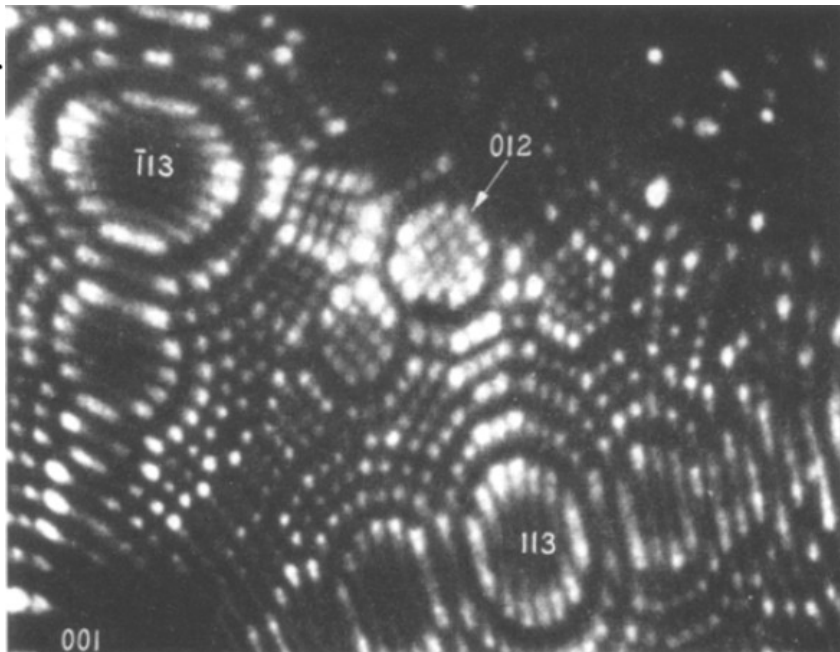


Henzler/Göpel: Oberflächenphysik des Festkörpers, Teubner

Ni₇Zr₂ tip



M. K. Miller et al.
(Oakridge National Laboratory)

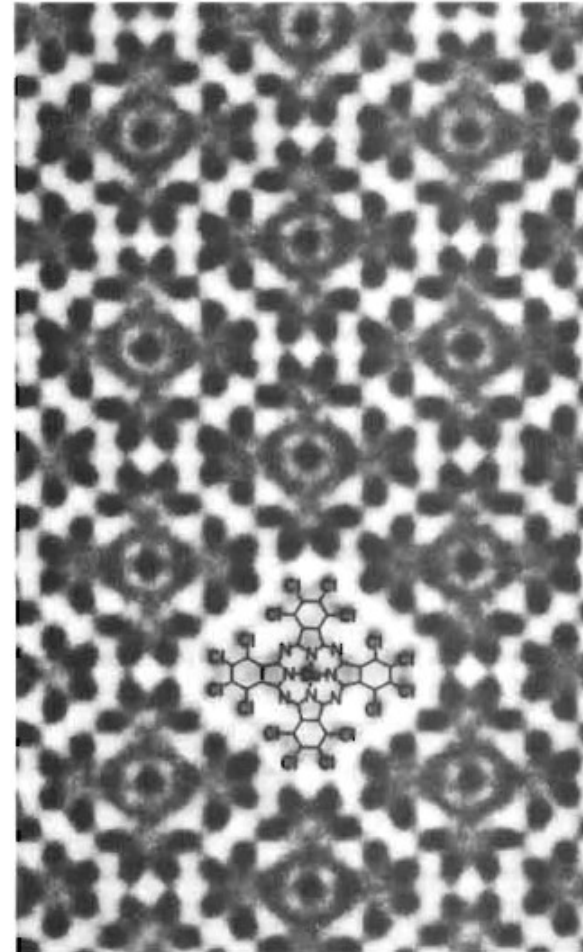
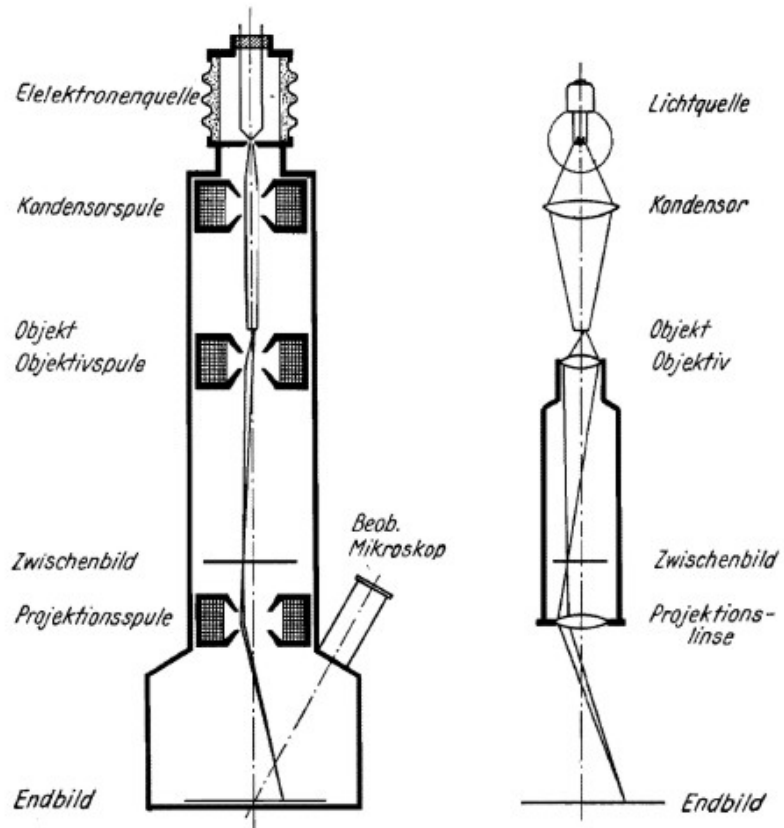


W tip

E. W. Müller, Z. F. Physik 156, 399 (1959)

Electron microscopy

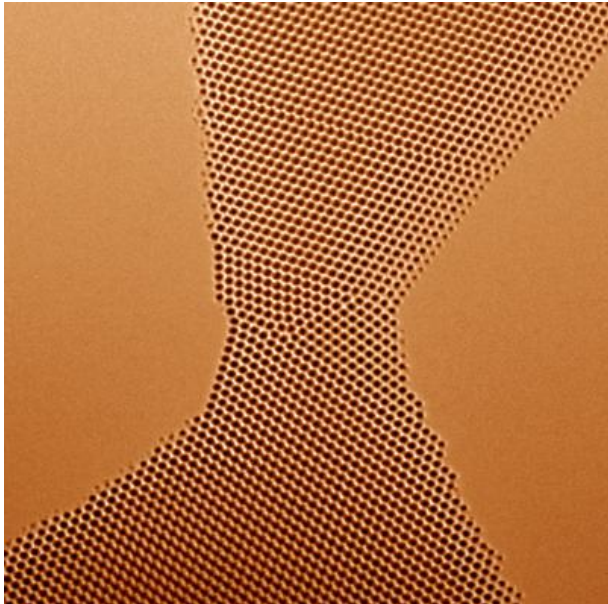
Single molecules (500 keV microscope)



Physik, Gerthsen et al (Springer 1992)

Electron microscopy

Au nanobridge
(TEM)



Au nanobridge
(TEM)

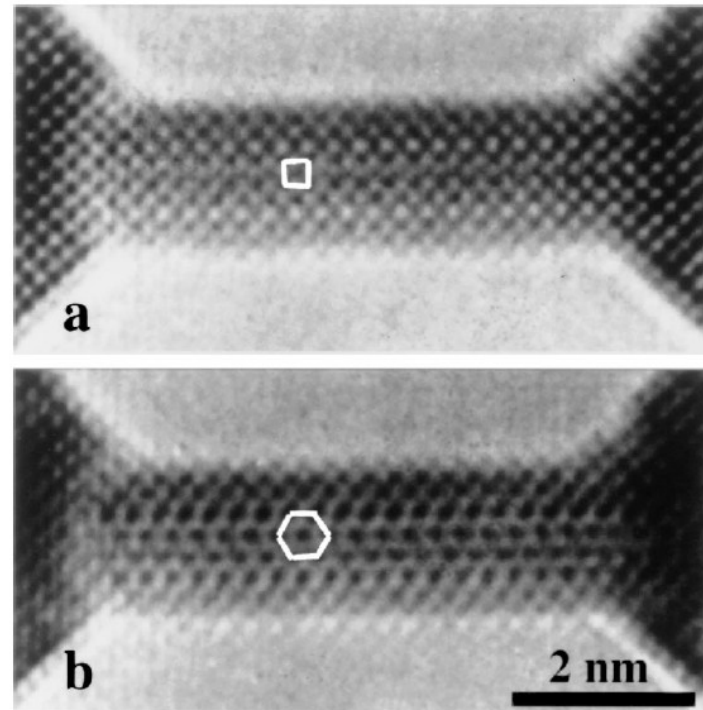
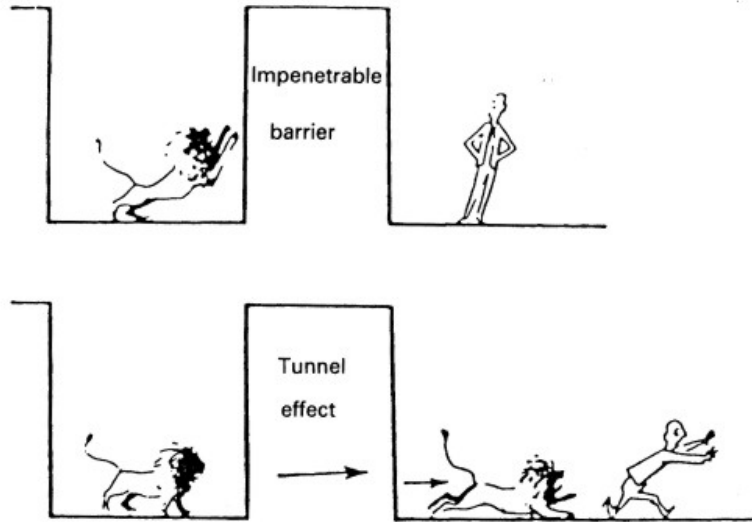


FIG. 2. Transmission electron micrographs of an NB 2 nm thick; obtained at the focuses of (a) 65 nm and (b) 55 nm. Note the square lattice in (a) and hexagonal one in (b).

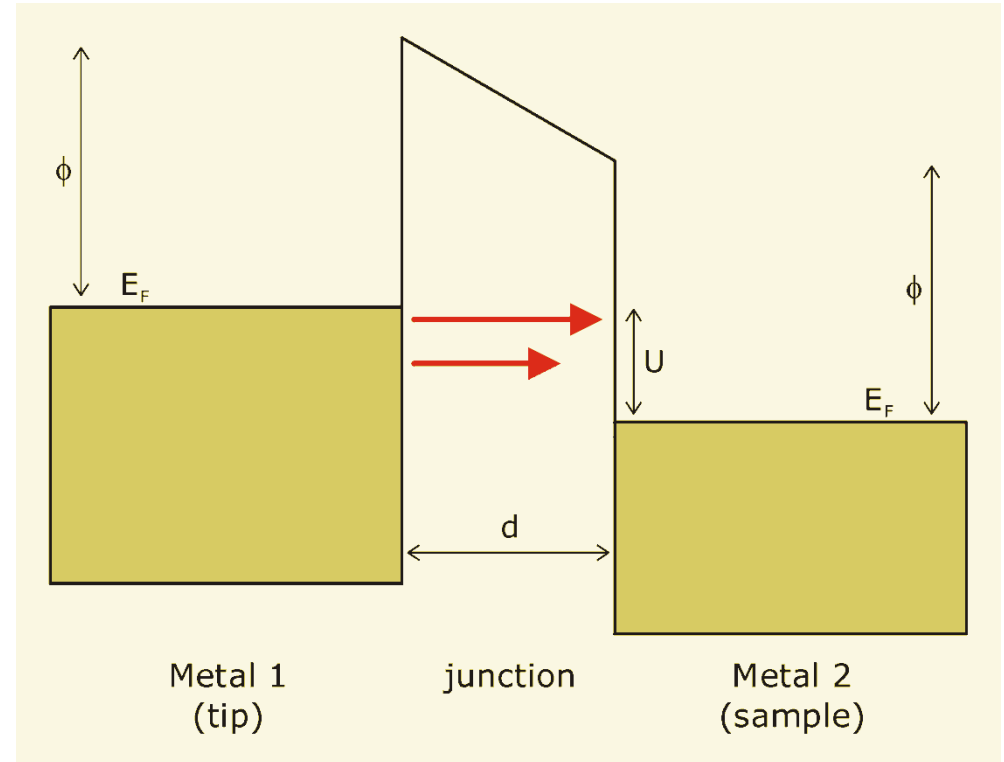
Y. Kondo et al., Phys. Rev. Lett. 79, 3455 (1997)

STM



B. Bleaney, *Contemp. Phys.* 25, 320 (1984)

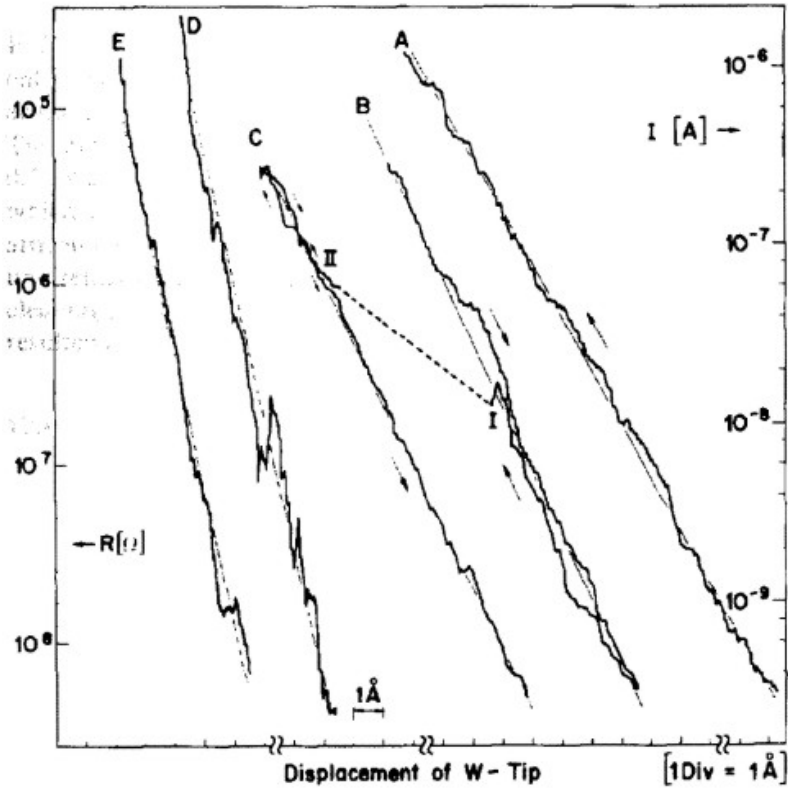
STM concept



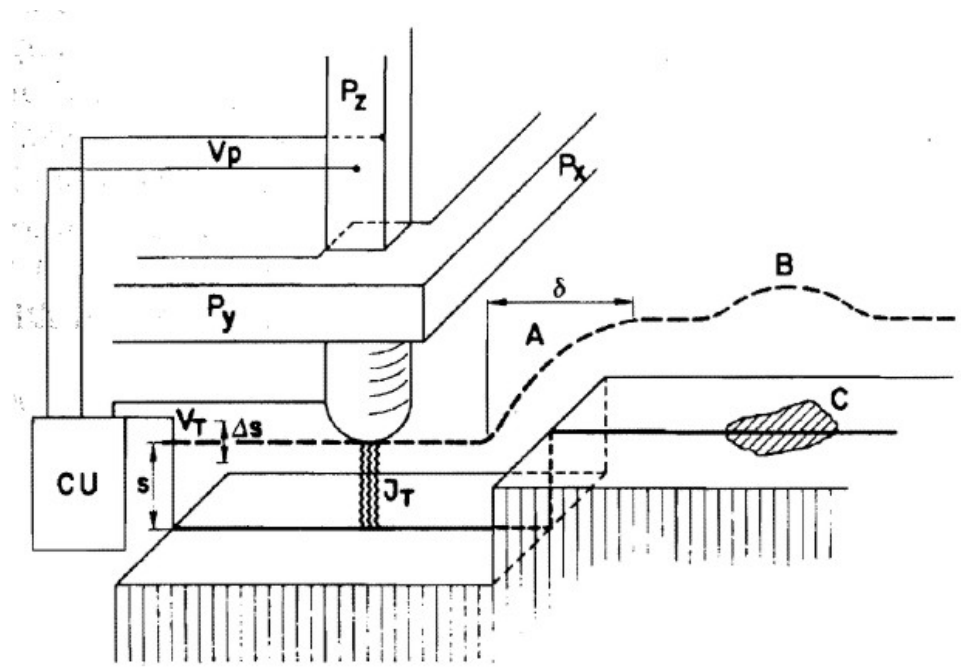
$$I \sim U \cdot e^{-2kd}$$

$$k = \frac{\sqrt{2m\Phi}}{\hbar}$$

Electron tunneling

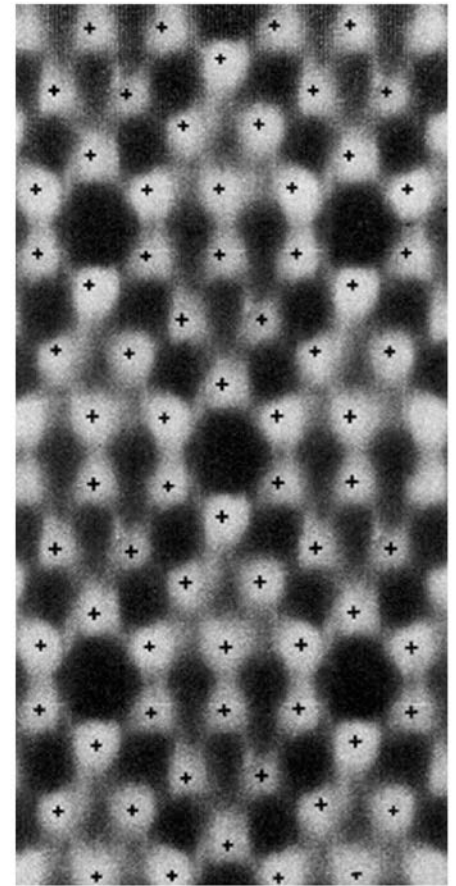
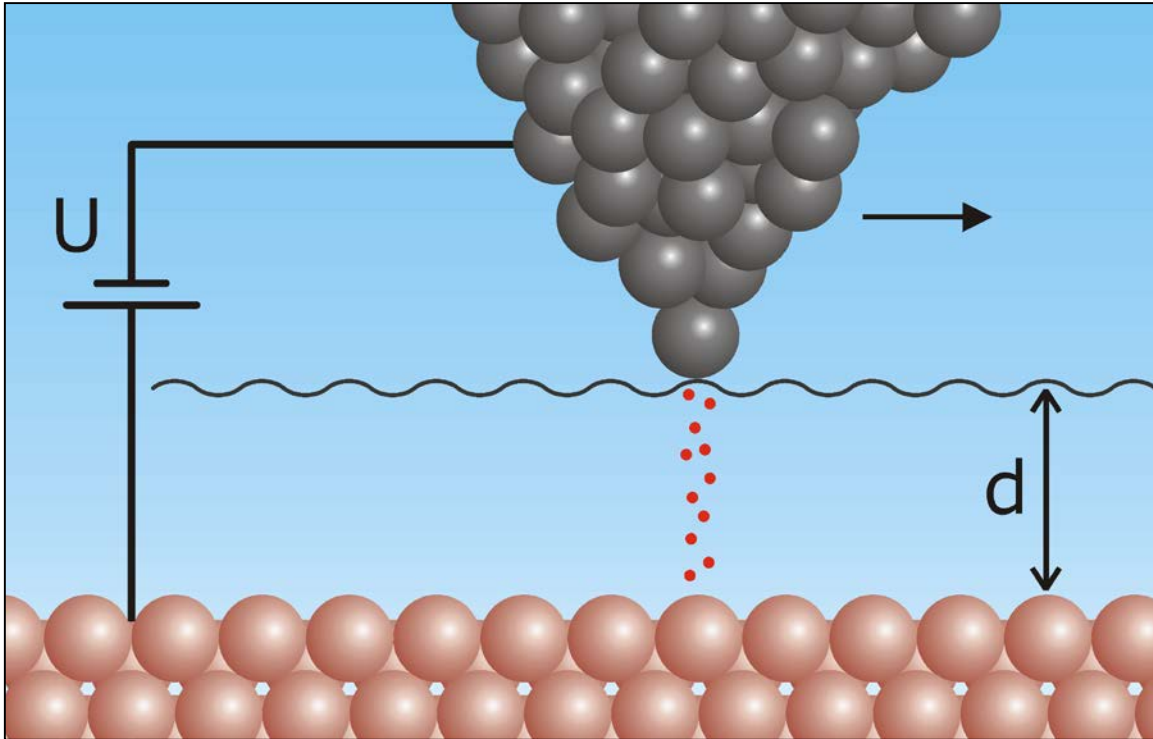


G. Binnig et al., Appl. Phys. Lett. 40, 178 (1982)



G. Binnig et al., Phys. Rev. Lett. 49, 57 (1982)

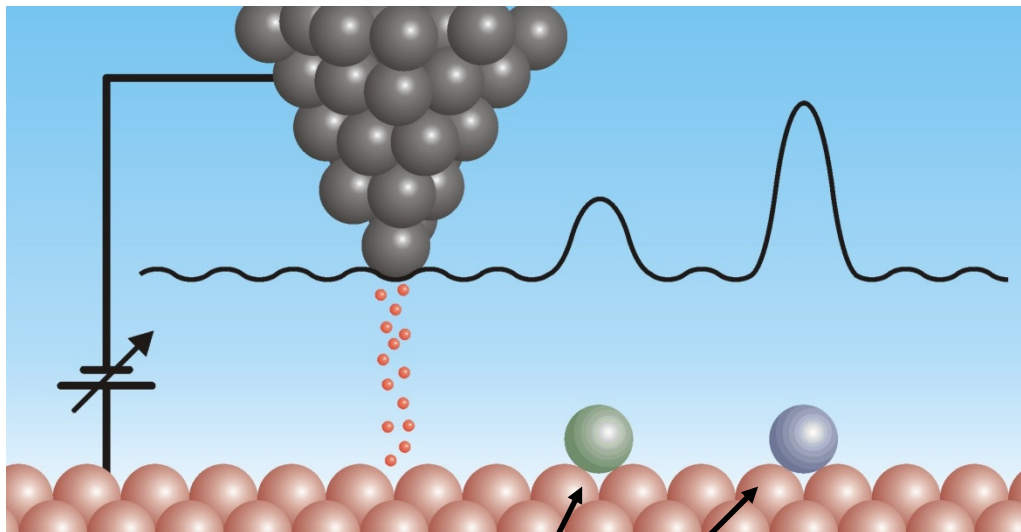
STM



Si(111) 7x7 reconstruction

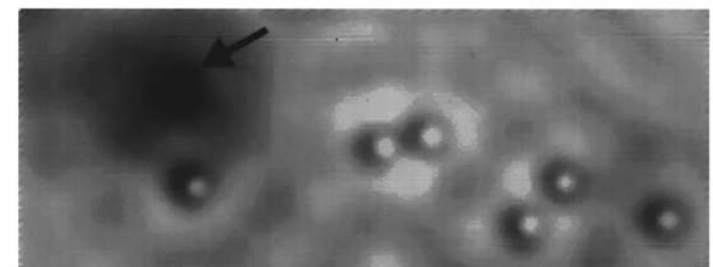
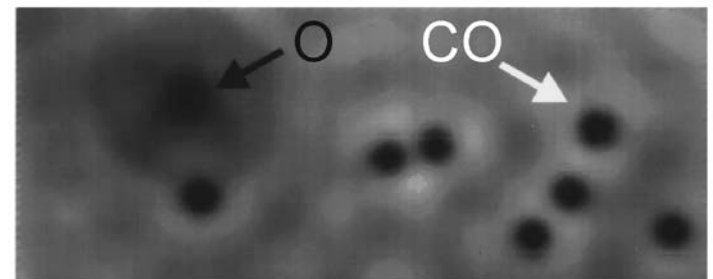
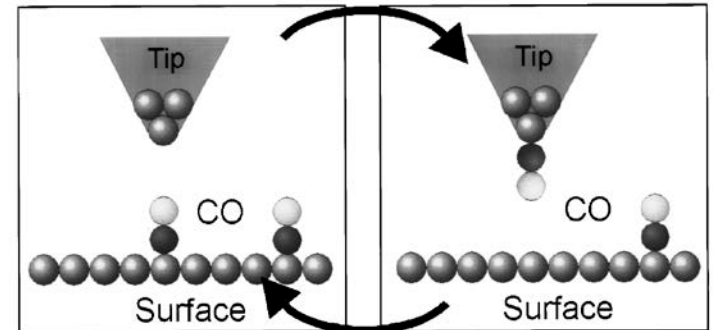
G. Binnig, H. Rohrer,
Ch. Gerber, and E. Weibel
Phys. Rev. Lett. **50**, 120 (1983)

„Chemical contrast“



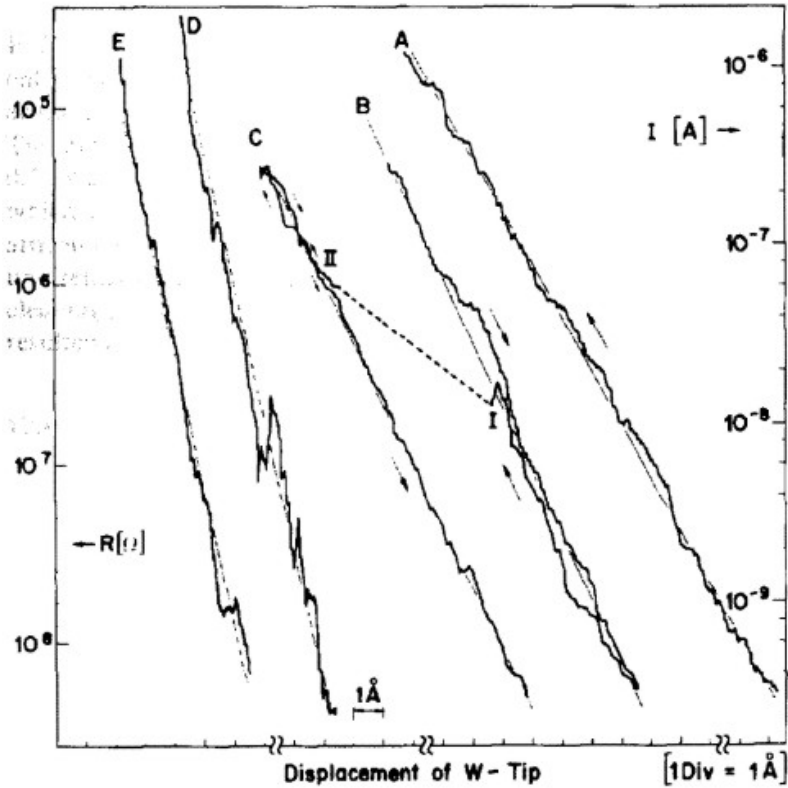
Different atomic/molecular species

Oxygen and CO on Cu(111)

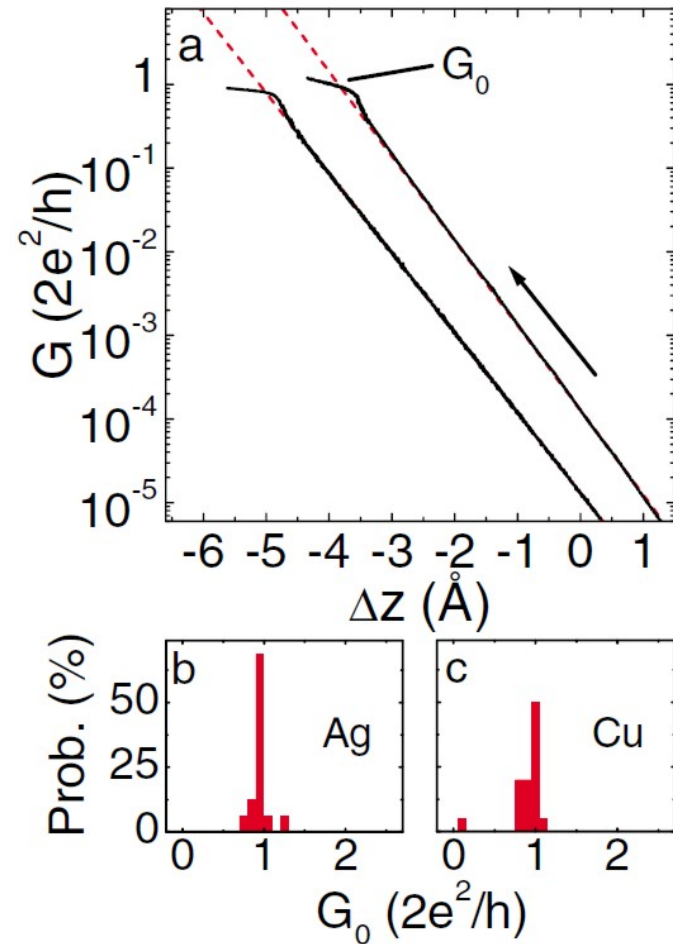


L. Bartels et al., APL 71, 213 (1997)

Point contact

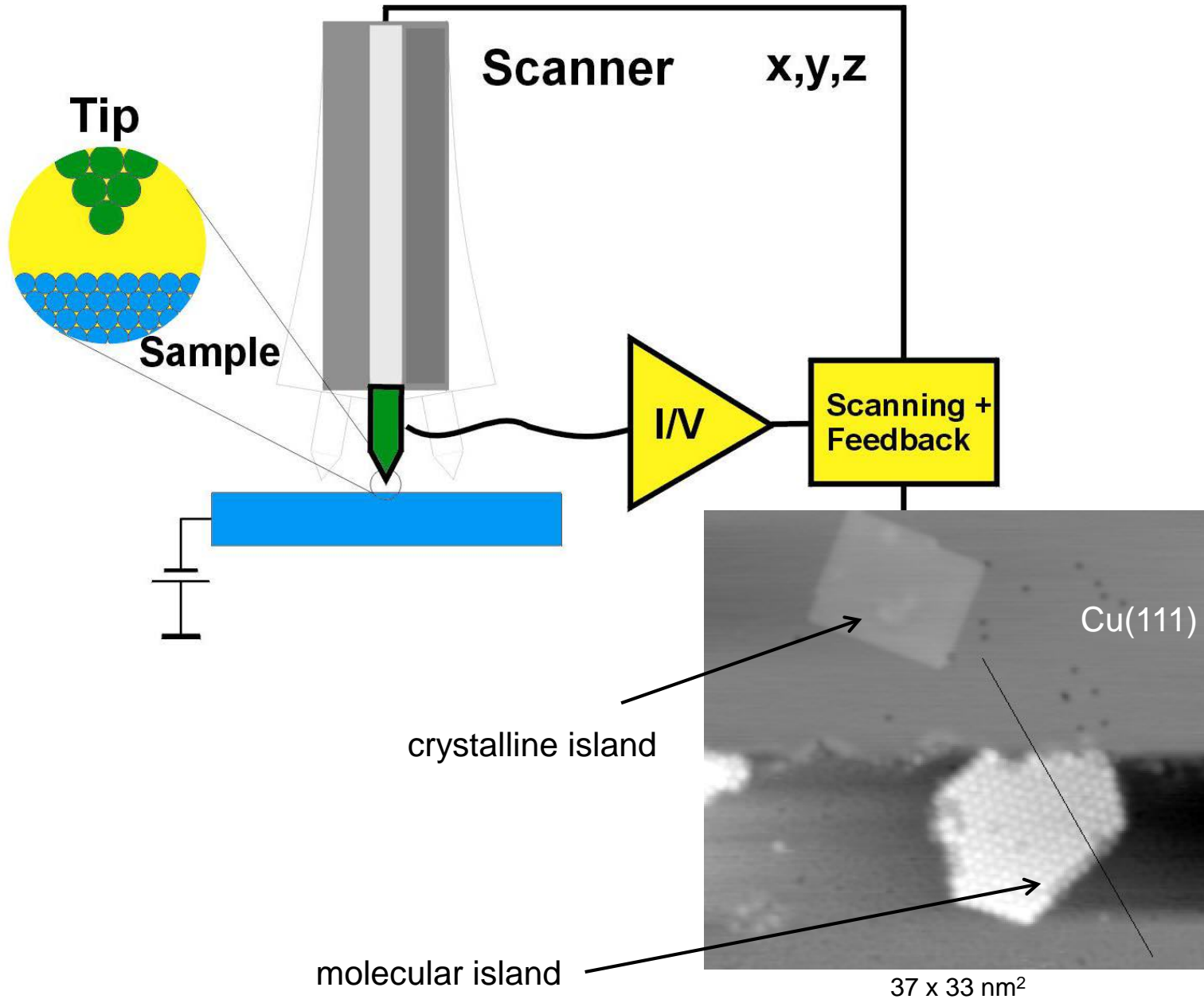


G. Binnig et al., *Appl. Phys. Lett.* 40, 178 (1982)



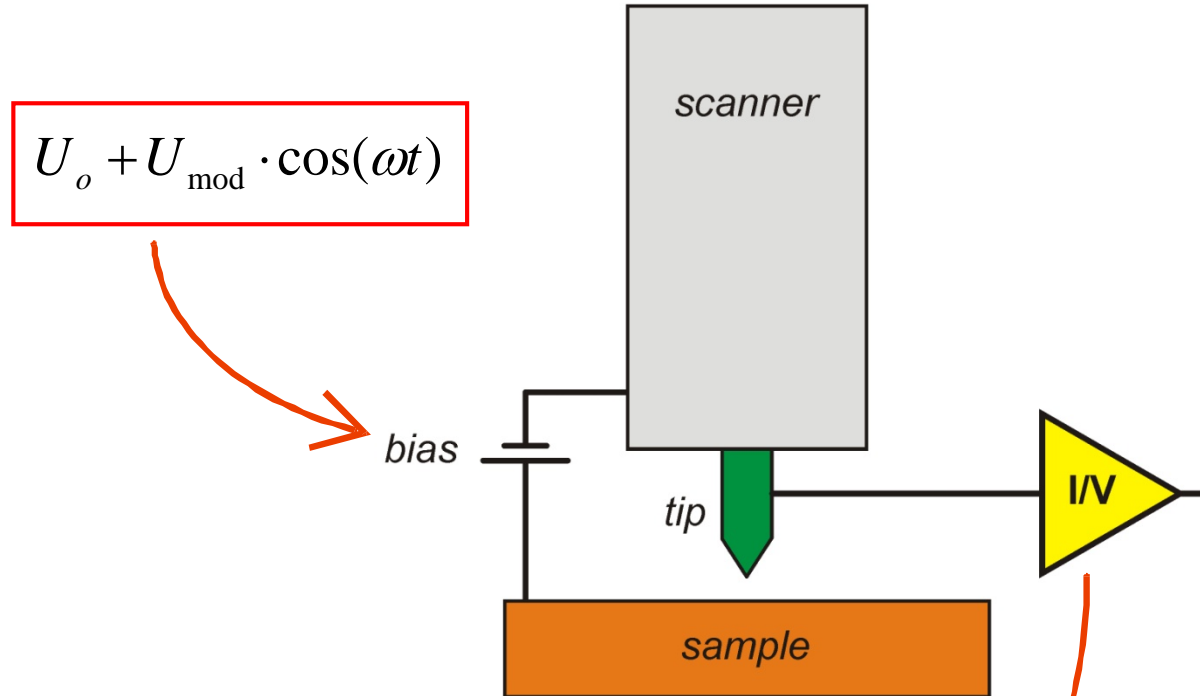
R. Berndt, *Phys. Rev. Lett.* 94, 126102 (2005)

Feedback loop



Spectroscopy

$$\frac{dI}{dV} \approx D_s(E_F + eU)$$



$$I = I_o + \frac{dI(U_o)}{dU} \cdot U_{\text{mod}} \cdot \cos(\omega t) + \frac{d^2 I(U_o)}{dU^2} \cdot U_{\text{mod}}^2 \cdot \cos^2(\omega t) + \dots$$

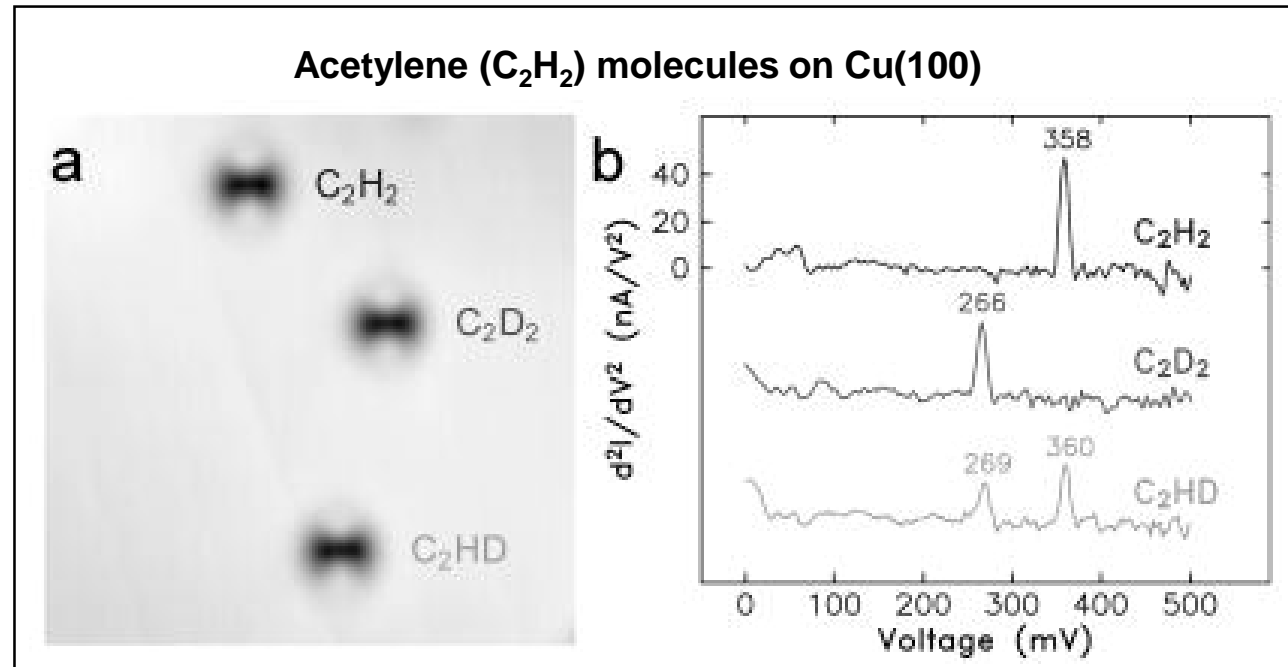
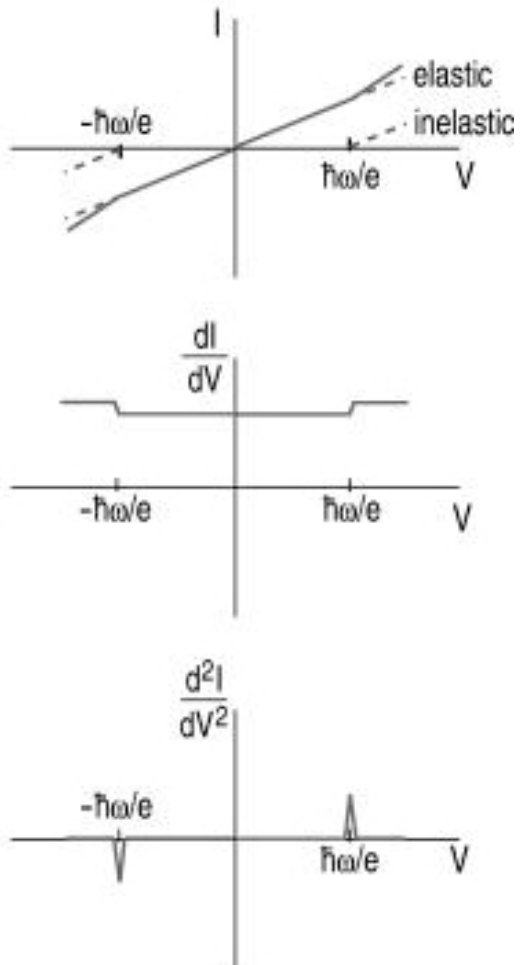
lock-in signal

$$\frac{1}{2} (1 + \cos(2\omega t))$$

Vibrational Spectroscopy - chemical identification

Current signal:
$$I = I_o + \frac{dI(U_o)}{dU} \cdot U_{\text{mod}} \cdot \cos(\omega t) + \frac{d^2I(U_o)}{dU^2} \cdot U_{\text{mod}}^2 \cdot \cos^2(\omega t) + \dots$$

$$\frac{1}{2}(1 + \cos(2\omega t))$$
 double frequency

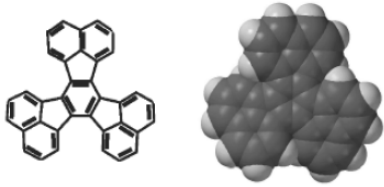


W. Ho, J. Chem. Phys. 117, 11033 (2002)

The role of the temperature: Required cooling

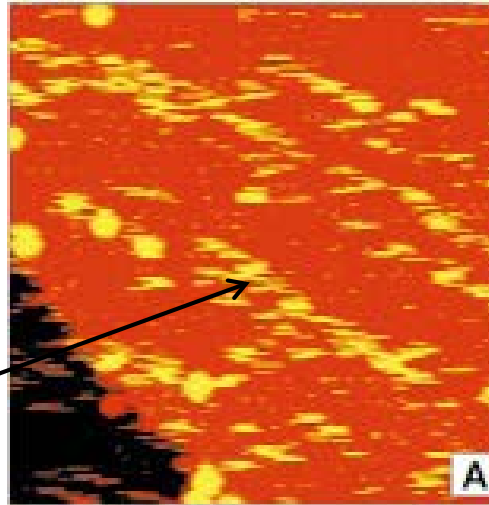
DC on Cu(110)

DC (decacyclene)

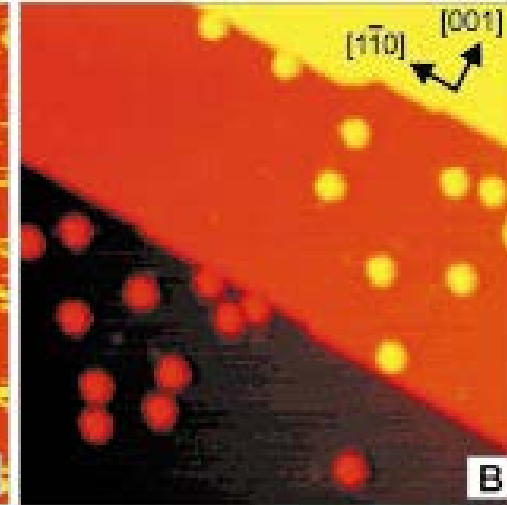


close-packed direction

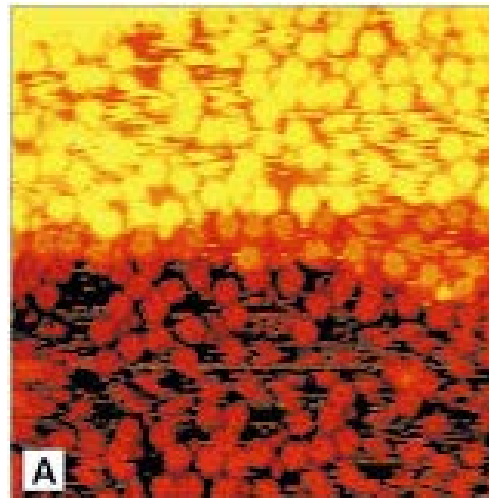
room temperature



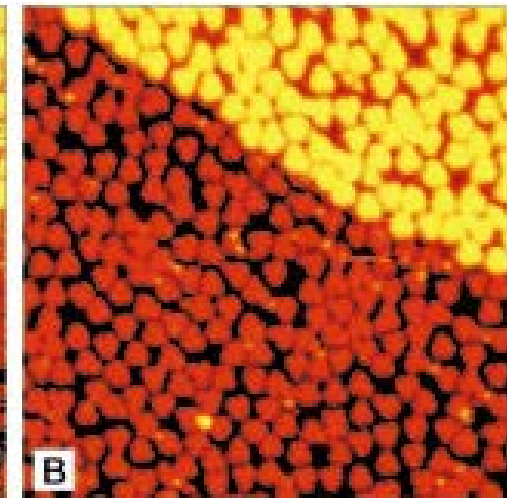
$T = 96 \text{ K}$



low coverage < 1 ML

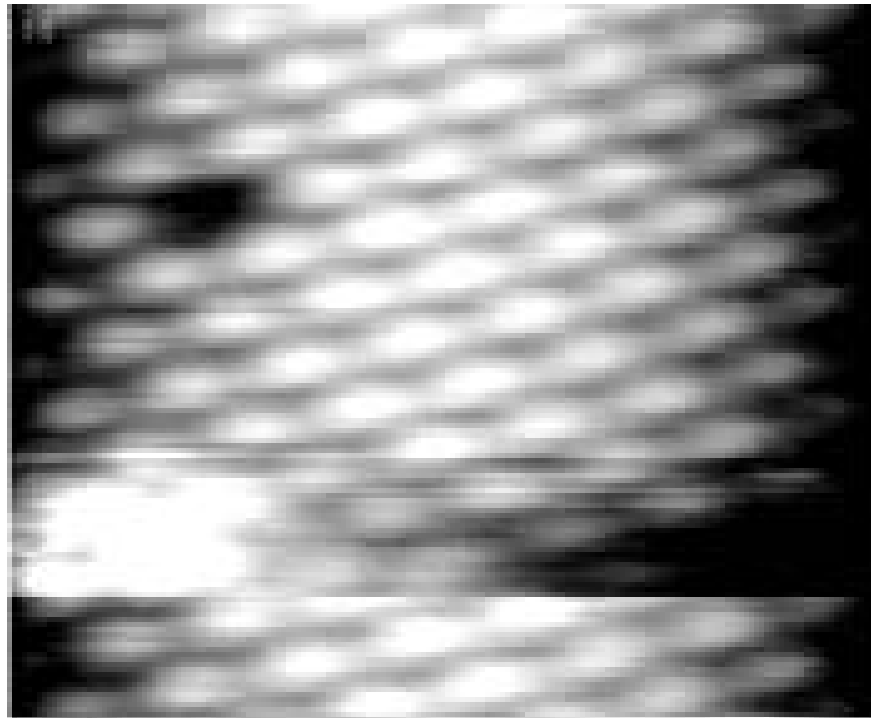
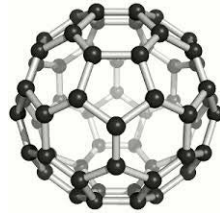


high coverage (1 ML)



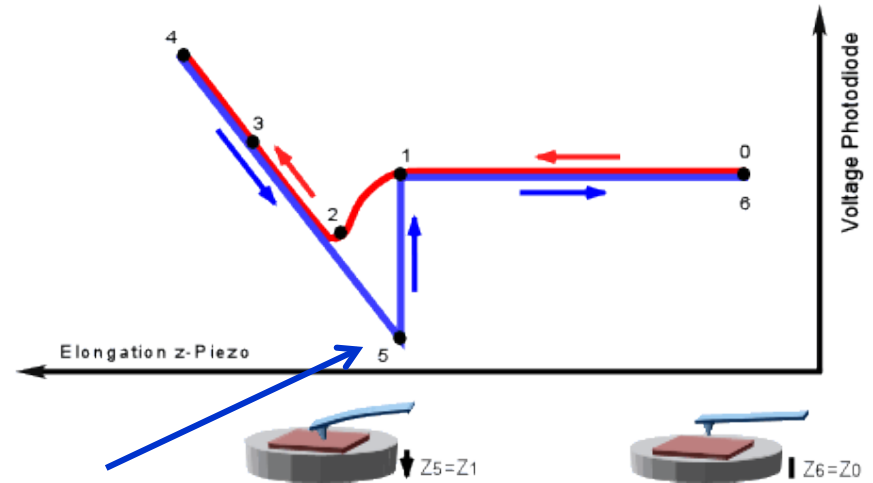
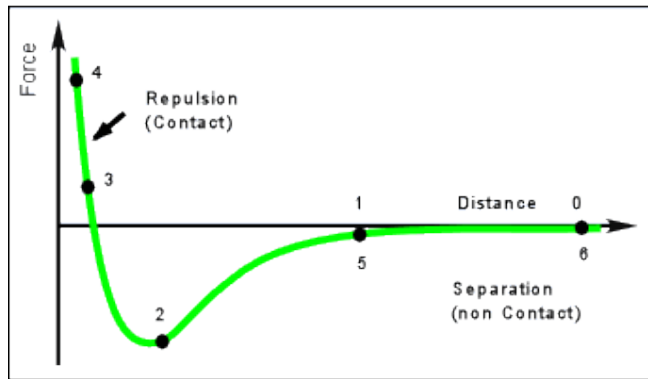
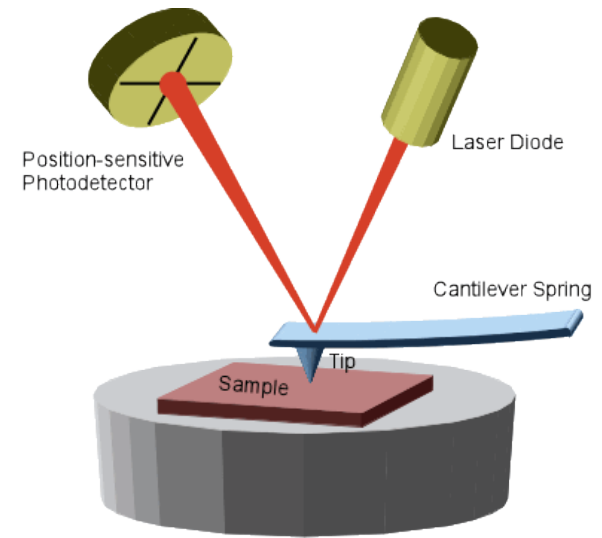
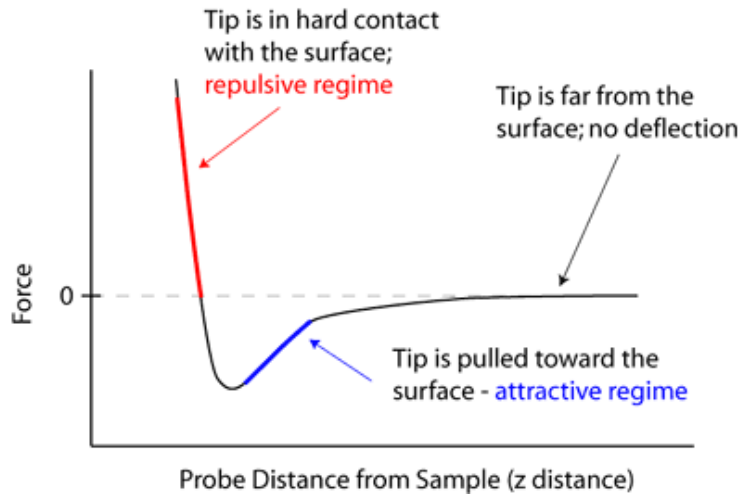
all images: 30 x 30 nm²

Fullerene C₆₀ on the gold surface Au(111)
Imaging at room temperature (real time)



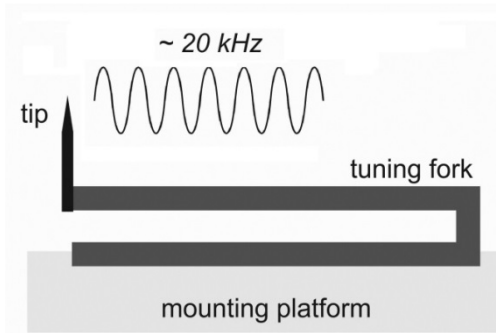
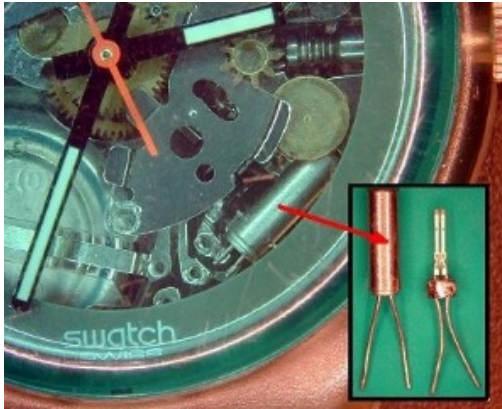
© F. Esch (TU München)

Atomic force microscopy (AFM)



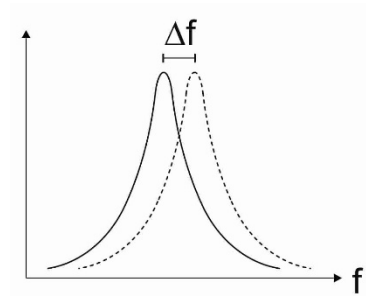
tip sticks in the surface and snaps back

Tuning fork atomic force microscope (AFM)



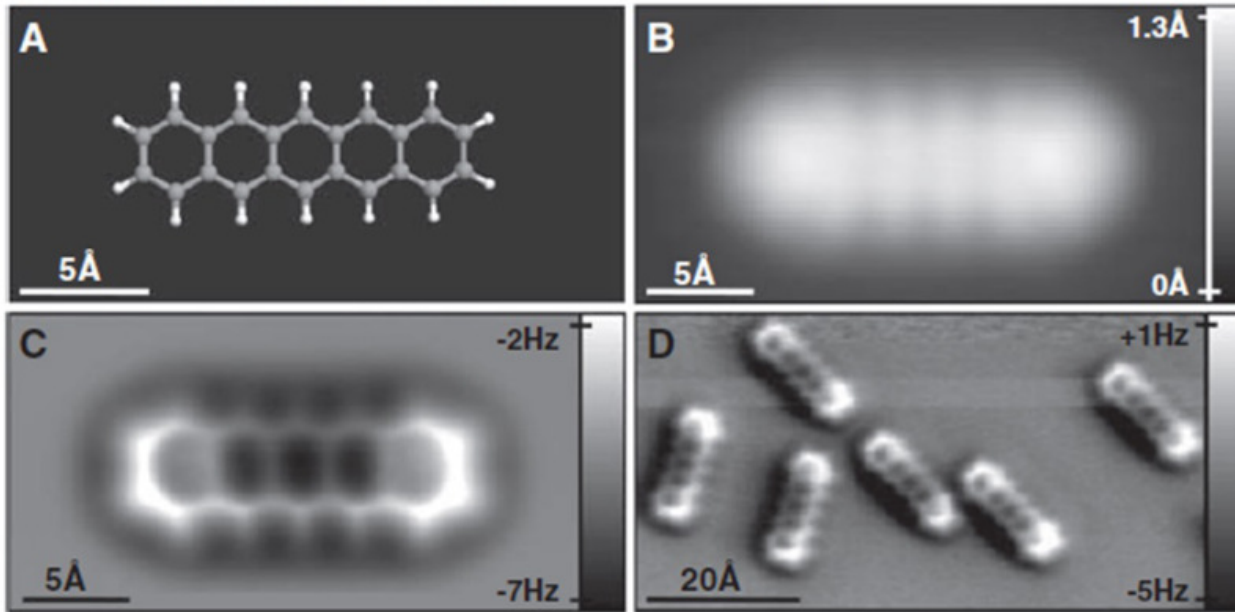
see F. J. Giessibl, *Rev. Mod. Phys.* 75, 949 (2003)

Measurement



Δf is caused by forces between tip and sample

Pentacene molecular model



Pentacene: Scanning tunneling "micrograph"

Pentacene: Atomic force "micrographs"

IR Spektroskopie

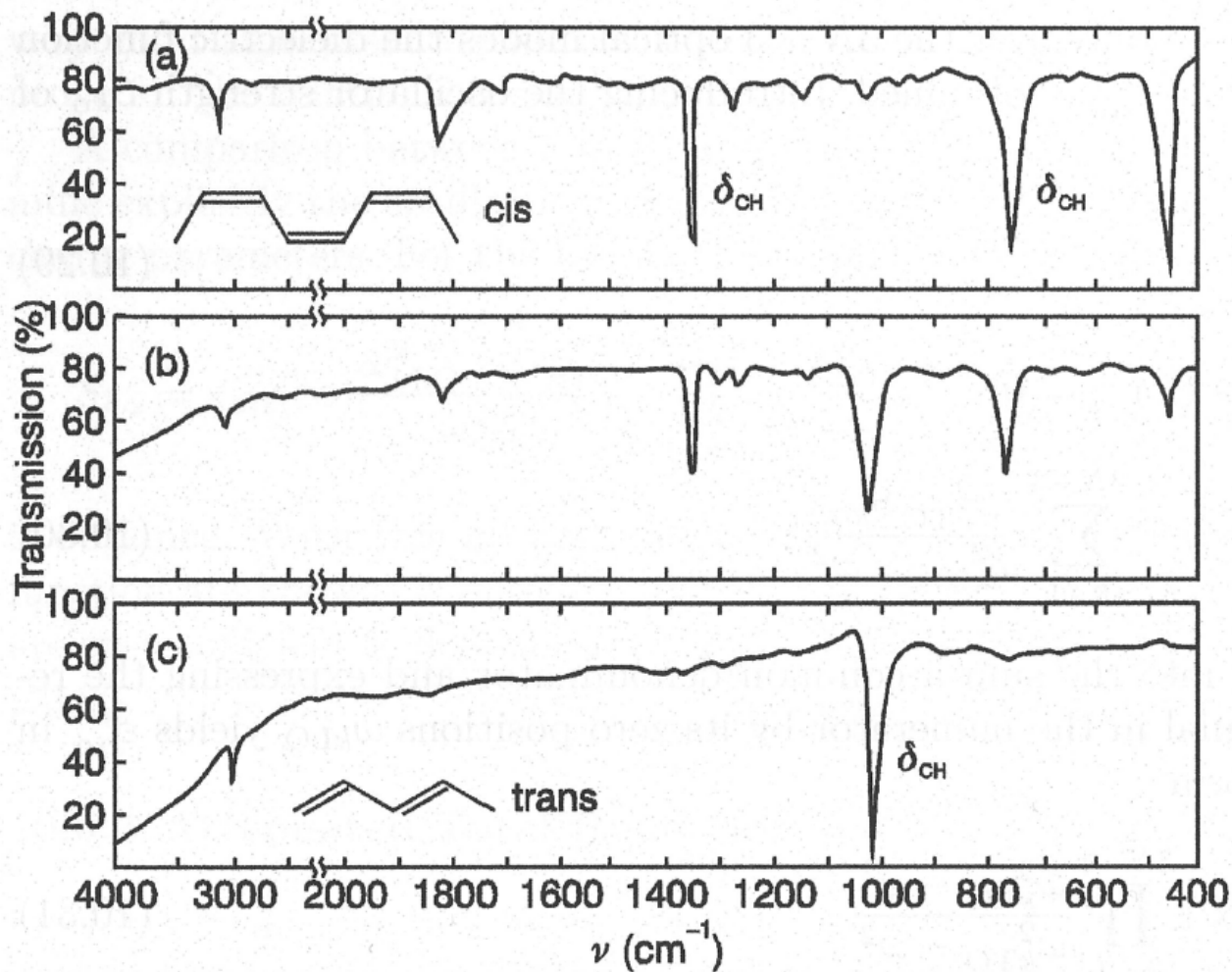
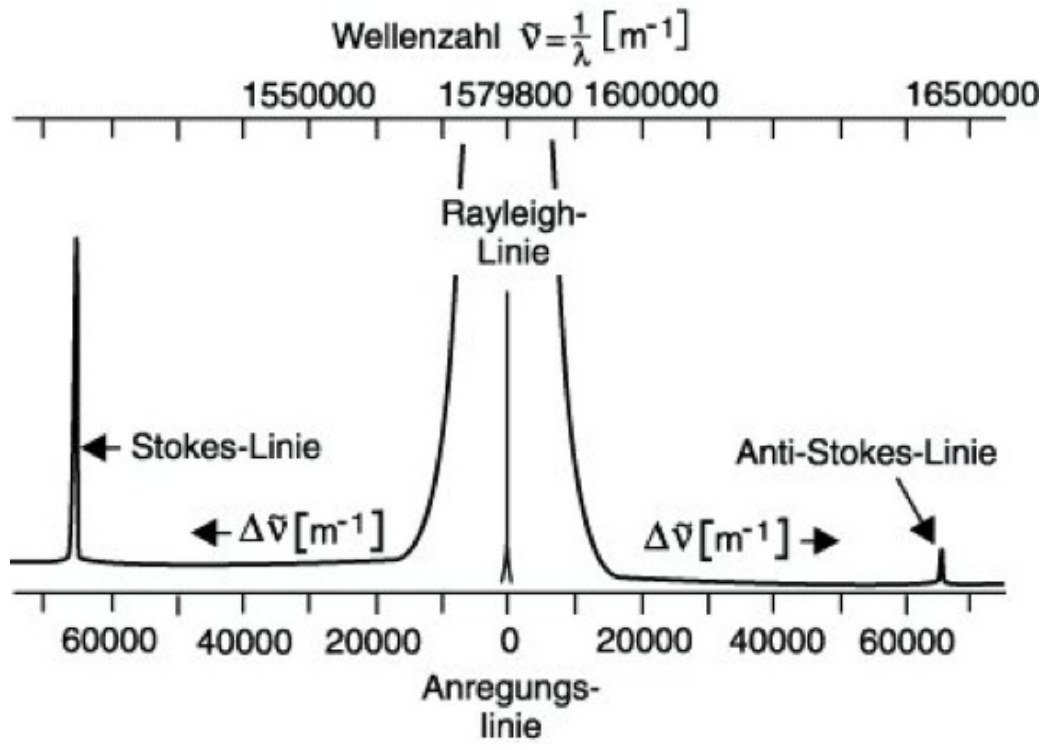
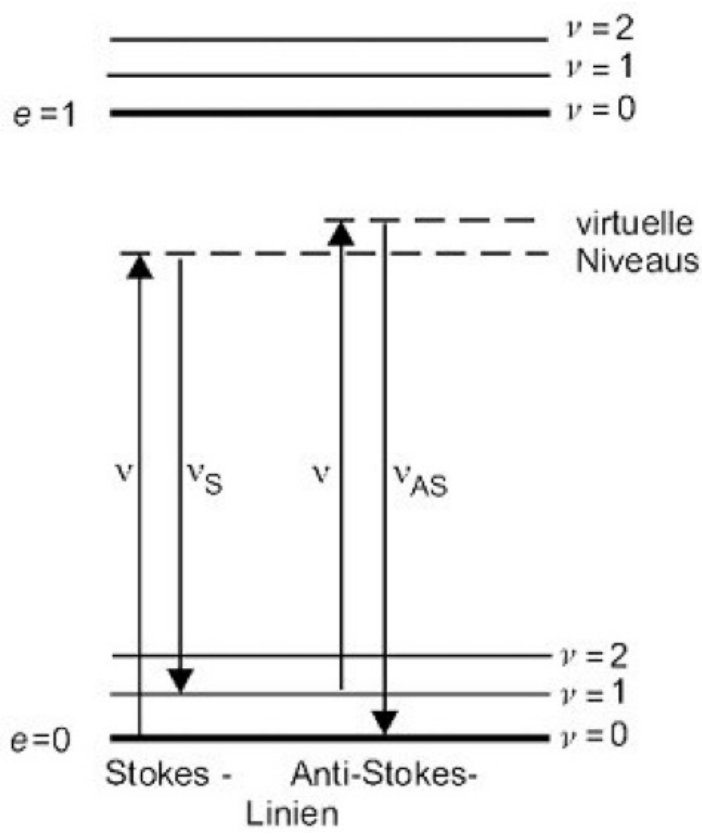


Fig. 10.17. Infrared transmission of cis-polyacetylene during the phase transition into the trans-form. cis-polyacetylene (a), intermediate phase (b), trans-polyacetylene (c); after [10.7]

Raman Spektroskopie



Lexikon der Optik (spektrum.de)

Raman Spektroskopie

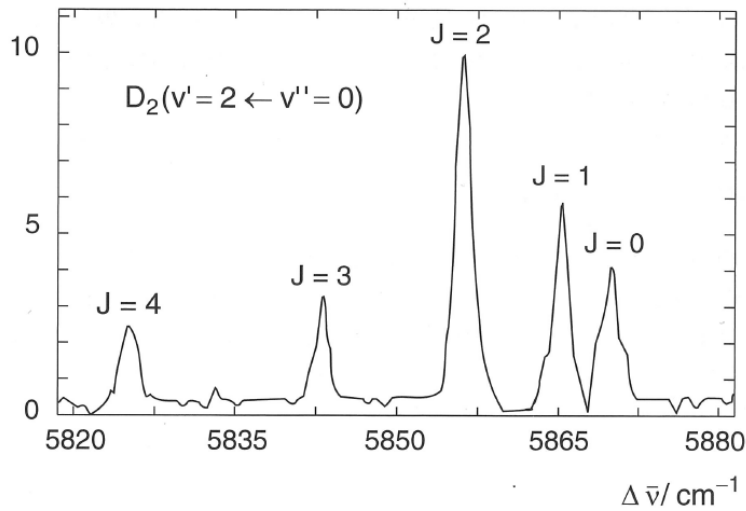


Abb. 10.12. Rotationsaufgelöster Q-Zweig im Oberton-Raman-Spektrum des D₂-Moleküls [10.9]

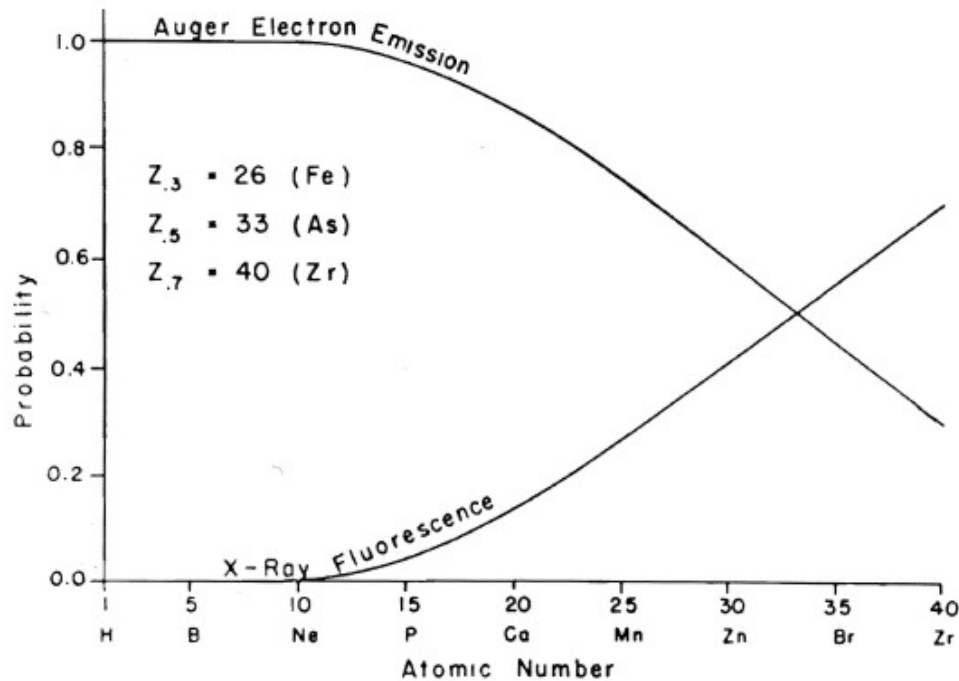
Demtröder: Experimentalphysik 3, Springer

molecule					
vibration					
change of α with Q					
$\frac{d\alpha}{dQ}$	$\neq 0$	$\neq 0$	$\neq 0$	$= 0$	$= 0$
Raman active	yes	yes	yes	no	no
change of \vec{P}_D with Q					
$\frac{d\vec{P}_D}{dQ}$	$= 0$	$\neq 0$	$= 0$	$\neq 0$	$\neq 0$
infrared active	no	yes	no	yes	yes

Fig. 9.4. Selection rules for Raman and for infrared activity of vibrations;

Kuzmany: Solid-State Spectroscopy, Springer

Auger Electron Spectroscopy (AES)



Briggs/Seah, *Practical Surface Analysis Vol.1* (Wiley)

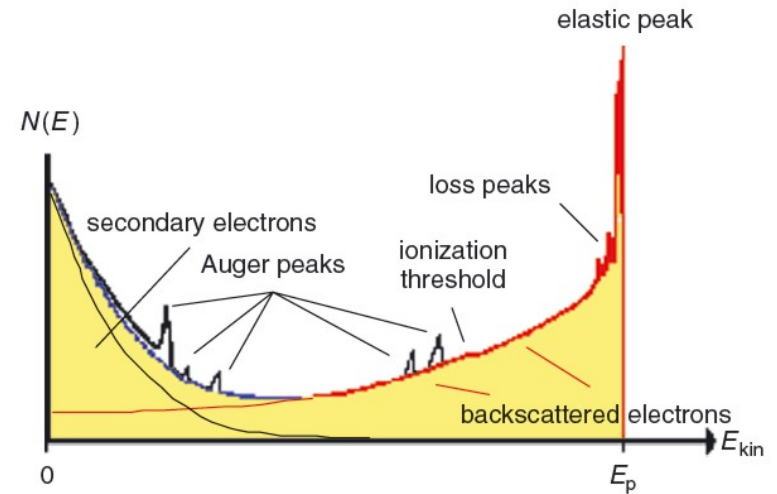


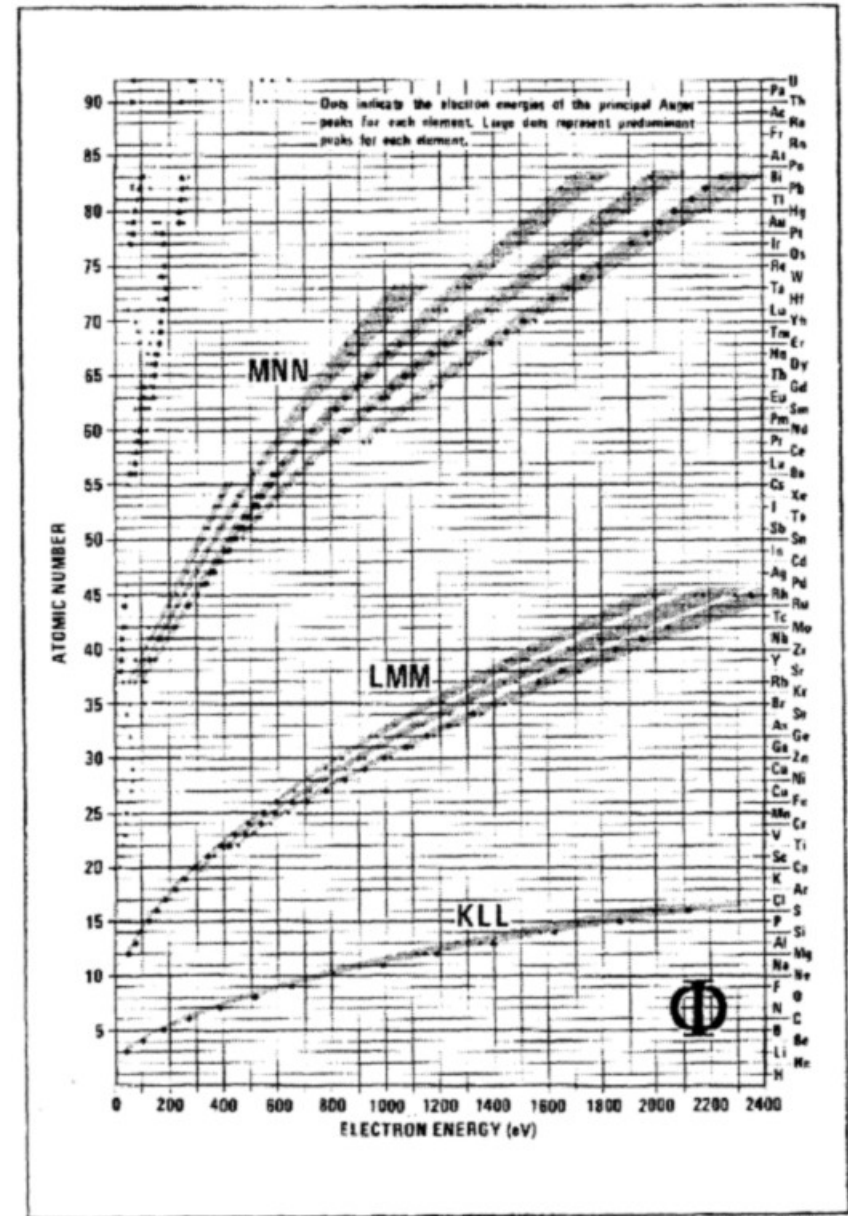
Figure 2.3 Schematic representation of an Auger spectrum

Surface Analysis – The Principal Techniques, Wiley (2009)

AES

Quantum numbers			X-ray suffix	X-ray level	Spectroscopic level
n	l	j			
1	0	$\frac{1}{2}$	1	K	$1s_{1/2}$
2	0	$\frac{1}{2}$	1	L_1	$2s_{1/2}$
2	1	$\frac{1}{2}$	2	L_2	$2p_{1/2}$
2	1	$\frac{3}{2}$	3	L_3	$2p_{3/2}$
3	0	$\frac{1}{2}$	1	M_1	$3s_{1/2}$
3	1	$\frac{1}{2}$	2	M_2	$3p_{1/2}$
3	1	$\frac{3}{2}$	3	M_3	$3p_{3/2}$
3	2	$\frac{3}{2}$	4	M_4	$3d_{3/2}$
3	2	$\frac{5}{2}$	5	M_5	$3d_{5/2}$
etc.			etc.	etc.	etc.

Briggs/Seah, Practical Surface Analysis Vol.1 (Wiley)

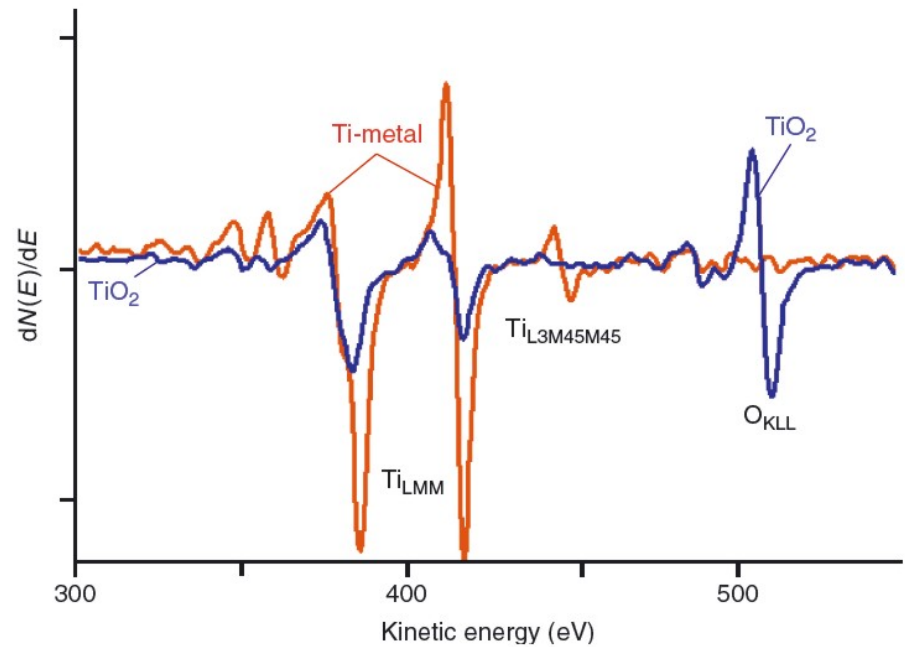
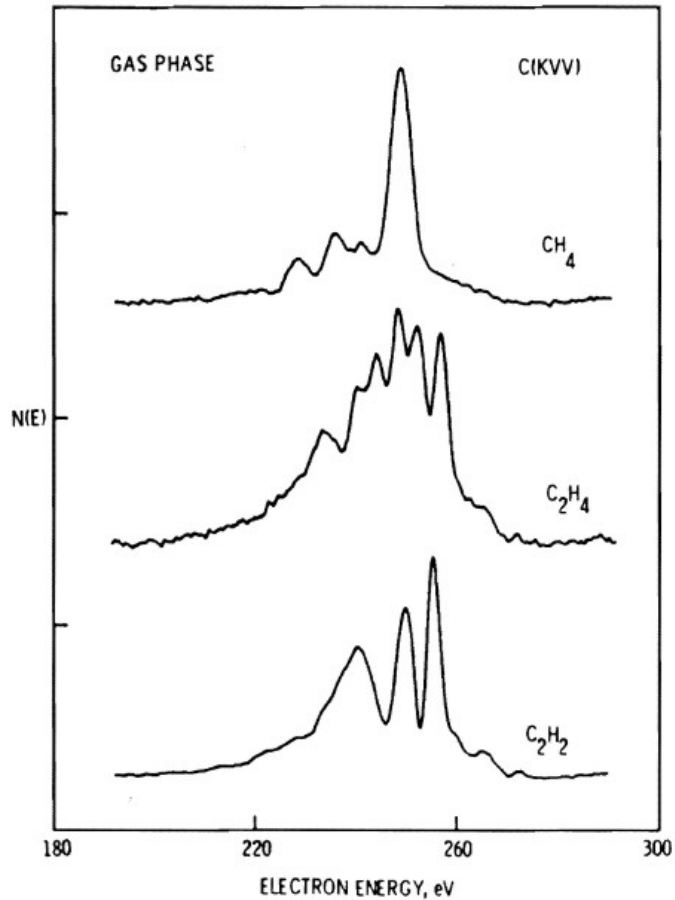


Handbook of Auger Electron Spectroscopy (1978)

Electron binding energies (in eV)

Z	EL	K	L1	L2	L3	M1	M2	M3	M4	M5
1	H	13.6								
2	HE	24.6								
3	LI	54.8	5.3							
4	BE	112.1	8.0							
5	B	188.0	12.6	4.7	4.7					
6	C	283.8	18.0	6.4	6.4					
7	N	401.6	24.4	9.2	9.2					
8	O	532.0	28.5	7.1	7.1					
9	F	685.4	34.0	8.6	8.6					
10	NE	870.1	48.5	21.7	21.6					
11	NA	1072.1	63.3	31.1	31.1	0.7				
12	MG	1305.0	89.4	51.4	51.4	2.1				
13	AL	1559.6	117.7	73.2	72.7	0.7	5.5	5.5		
14	SI	1838.9	148.7	99.5	98.9	7.6	3.0	3.0		
15	P	2145.5	189.3	136.2	135.3	16.2	9.9	9.9		
16	S	2472.0	229.2	165.4	164.2	15.8	8.0	8.0		
17	CL	2822.4	270.2	201.6	200.0	17.5	6.8	6.8		
18	AR	3206.0	326.3	250.7	248.6	29.2	15.9	15.8		
19	K	3607.4	377.1	296.3	293.6	33.9	17.8	17.8		
20	CA	4038.1	437.8	350.0	346.4	43.7	25.4	25.4		
21	SC	4492.8	500.4	406.7	402.2	53.8	32.3	32.3	6.6	6.6
22	TI	4966.4	563.7	461.5	455.5	60.3	34.6	34.6	3.7	3.7
23	V	5465.1	628.2	520.5	512.9	66.5	37.8	37.8	2.2	2.2
24	CR	5989.2	694.6	583.7	574.5	74.1	42.5	42.5	2.3	2.3
25	MN	6539.0	769.0	651.4	640.3	83.9	49.6	48.6	3.3	3.3
26	FE	7112.0	846.1	721.1	708.1	92.9	54.0	54.0	3.6	3.6
27	CO	7708.9	925.6	793.6	778.6	100.7	59.5	59.5	2.9	2.9
28	NI	8332.8	1008.1	871.9	854.7	111.8	68.1	68.1	3.6	3.6
29	CU	8978.9	1096.1	951.0	931.1	119.8	73.6	73.6	1.6	1.6
30	ZN	9658.6	1193.6	1042.8	1019.7	135.9	96.6	86.6	8.1	8.1

Auger chemical fine structure

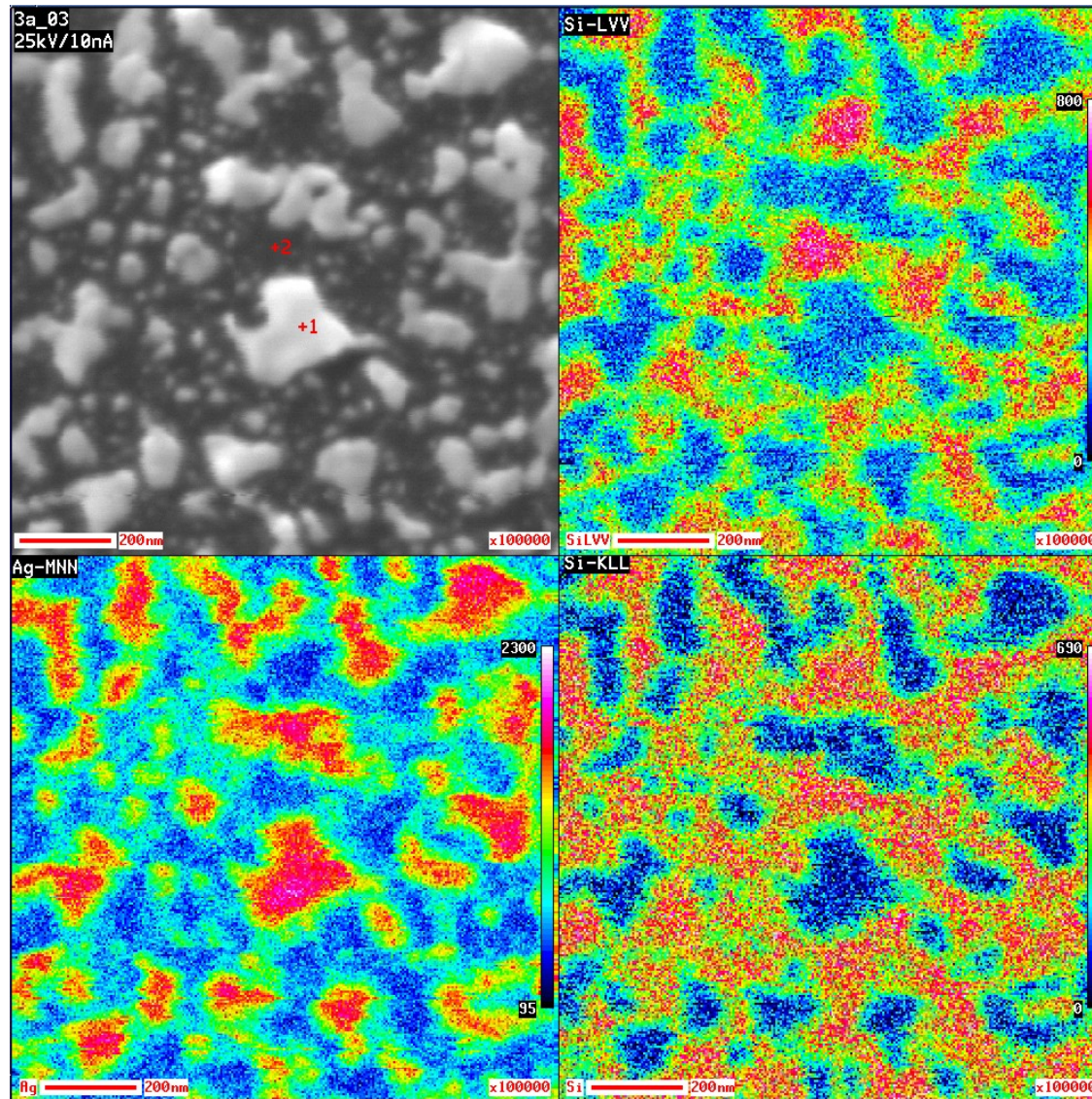


Surface Analysis – The Principal Techniques, Wiley (2009)

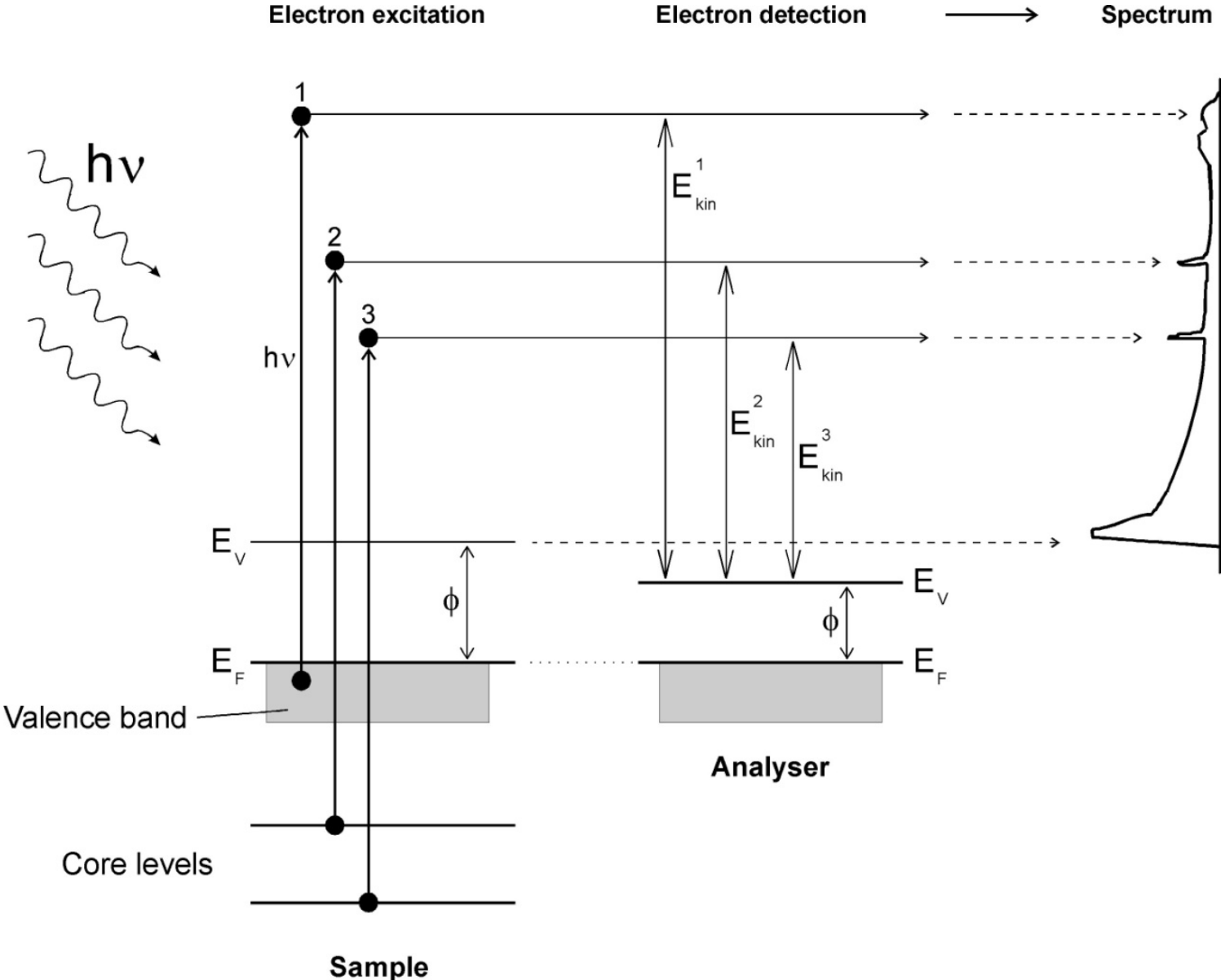
Briggs/Seah, Practical Surface Analysis Vol.1 (Wiley)

Scanning Auger Microscopy (SAM)

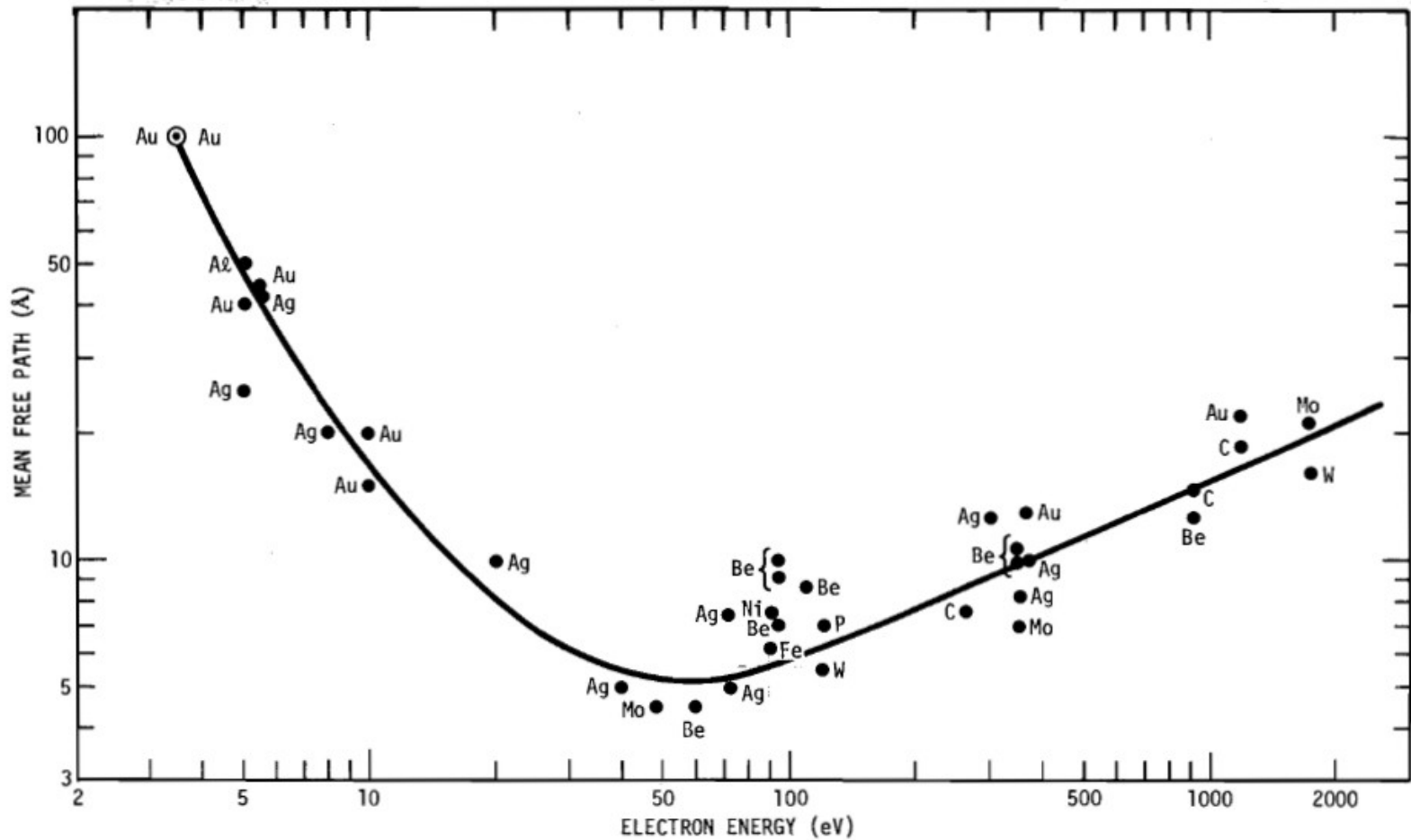
Ag clusters on a Si surface



Photoemissionsspektroskopie



Elektronenweglänge in Festkörpern: „Universal curve“



G. A. Somorjai, *Chemistry in two dimensions: Surfaces*

Photoemissionsspektroskopie

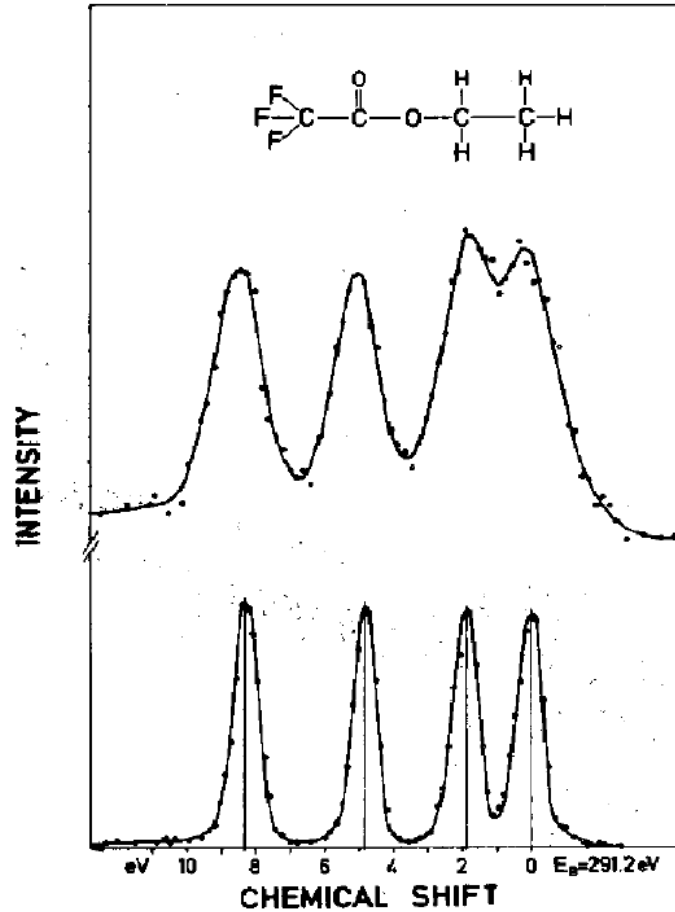
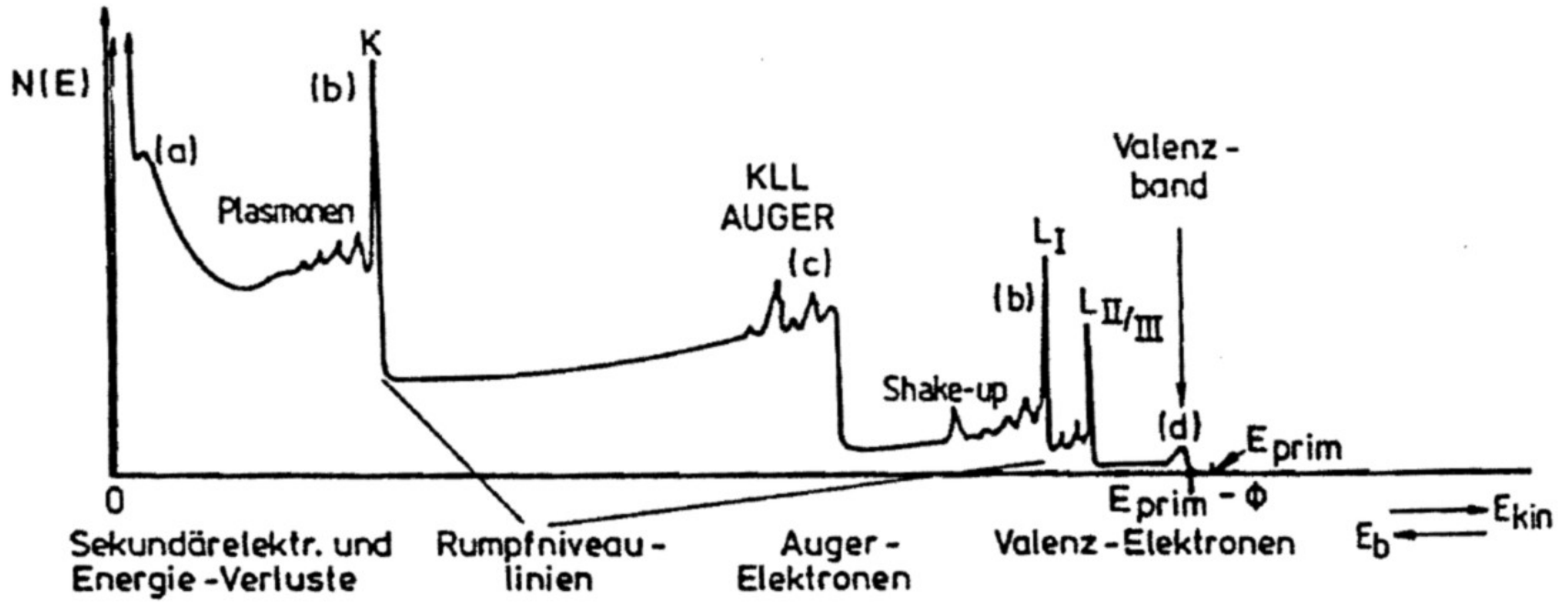


Fig. 28. The ESCA shifts of the C 1s in ethyl trifluoroacetate. Upper spectrum without and lower with monochromatization.

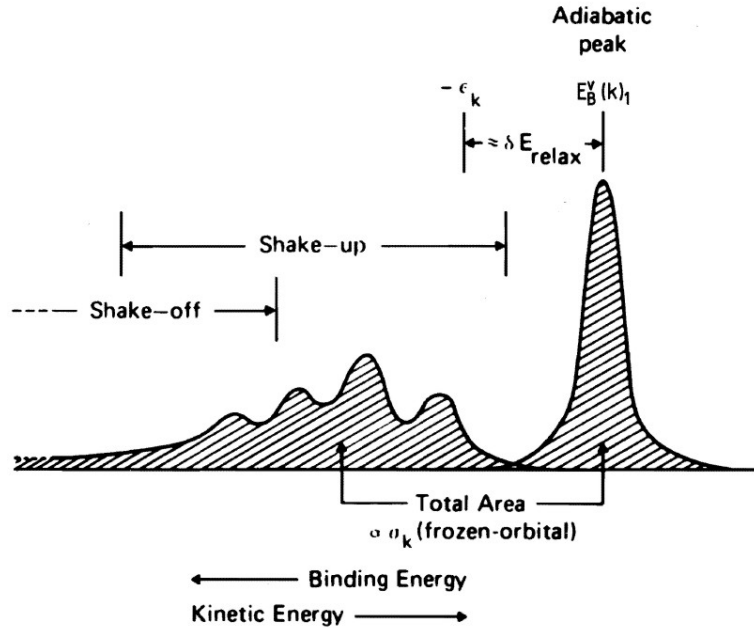
K. Siegbahn, J. El. Spectr. Rel. Phen. 5, 3 (1974)

Photoemissionsspektroskopie

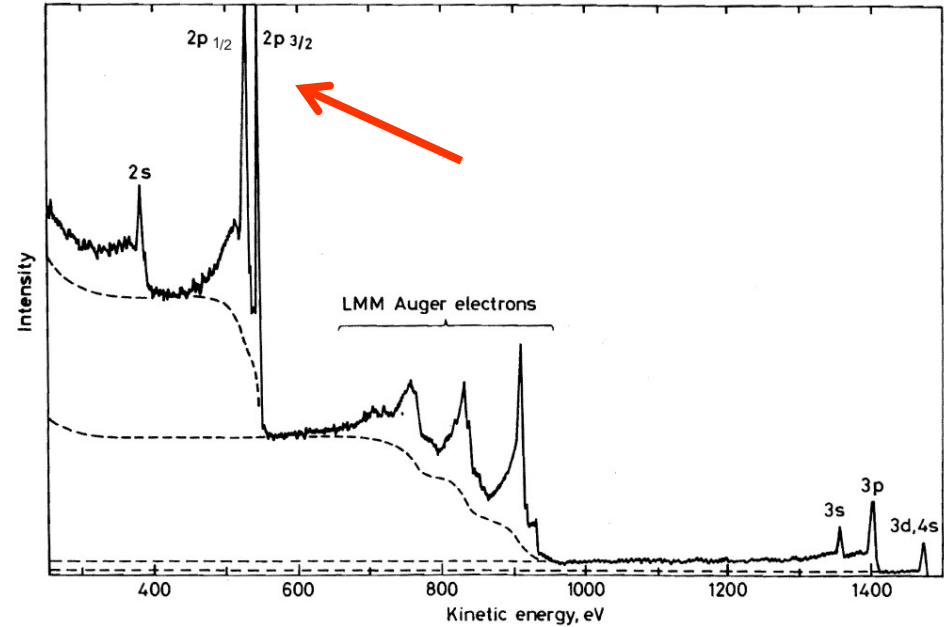


Henzler/Göpel: Oberflächenphysik des Festkörpers, Teubner

Photoemissionspektroskopie



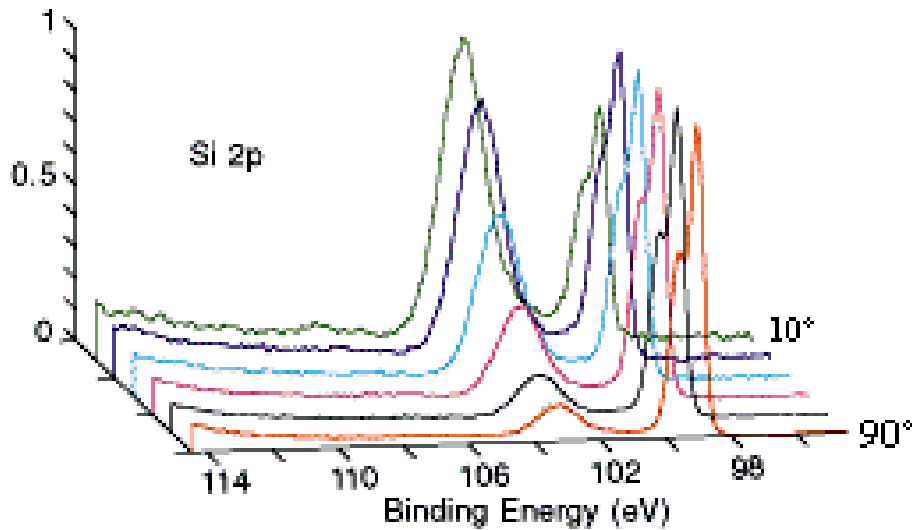
Ertl/Küppers, *Low energy electrons and surface chemistry*, VCH



Briggs/Seah, *Practical Surface Analysis Vol. 1* (Wiley)

Angle dependence

Si sample covered with an oxide layer
Si 2p for different emission angles

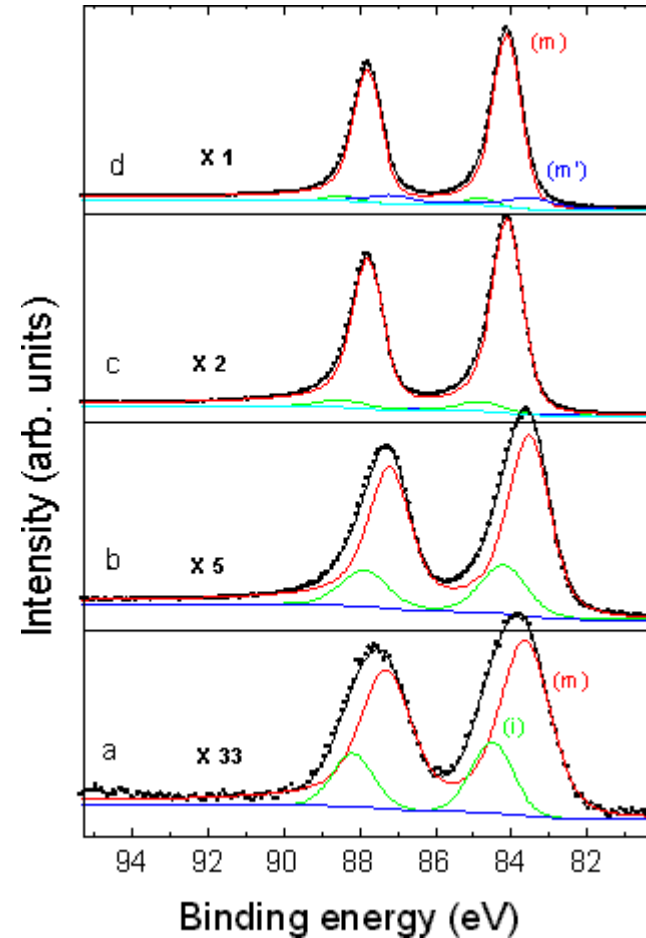


Physical Electronics, Inc. (PHI)

Si peak of the oxide at 103 eV changes...

Fitting

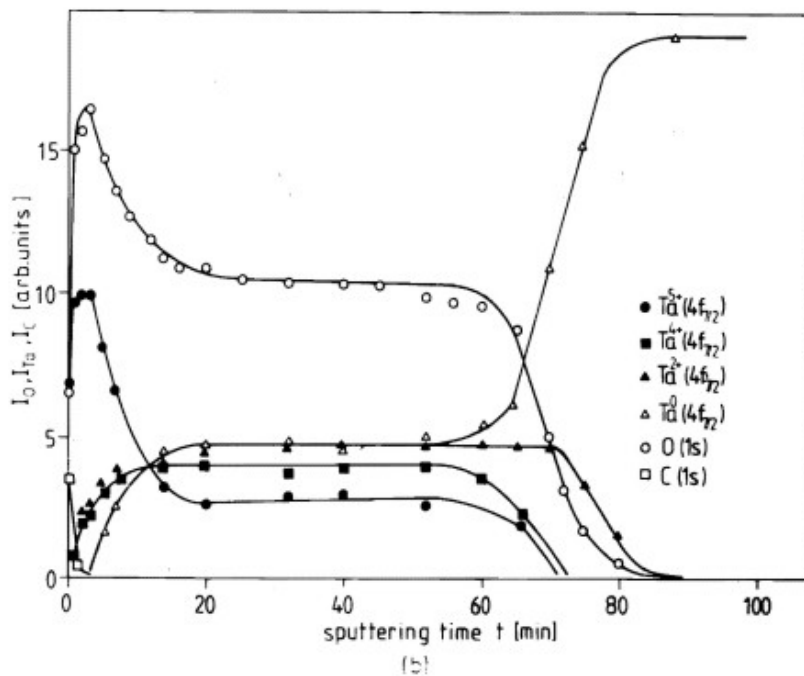
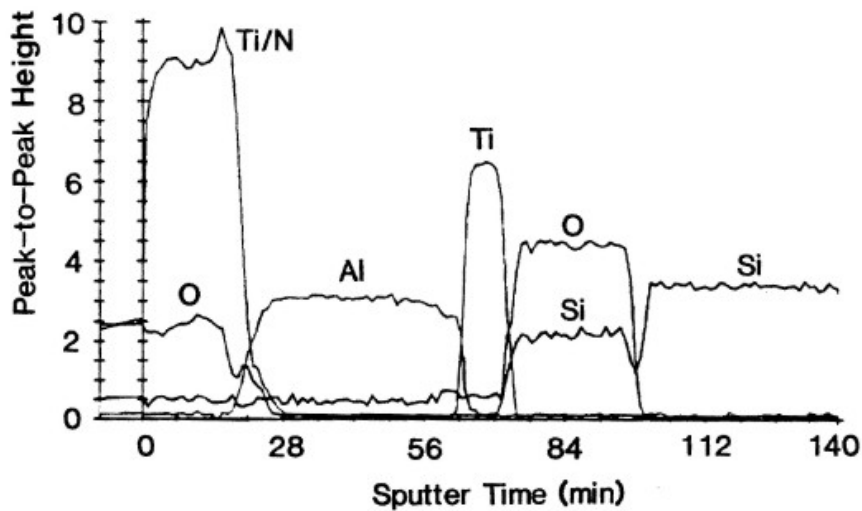
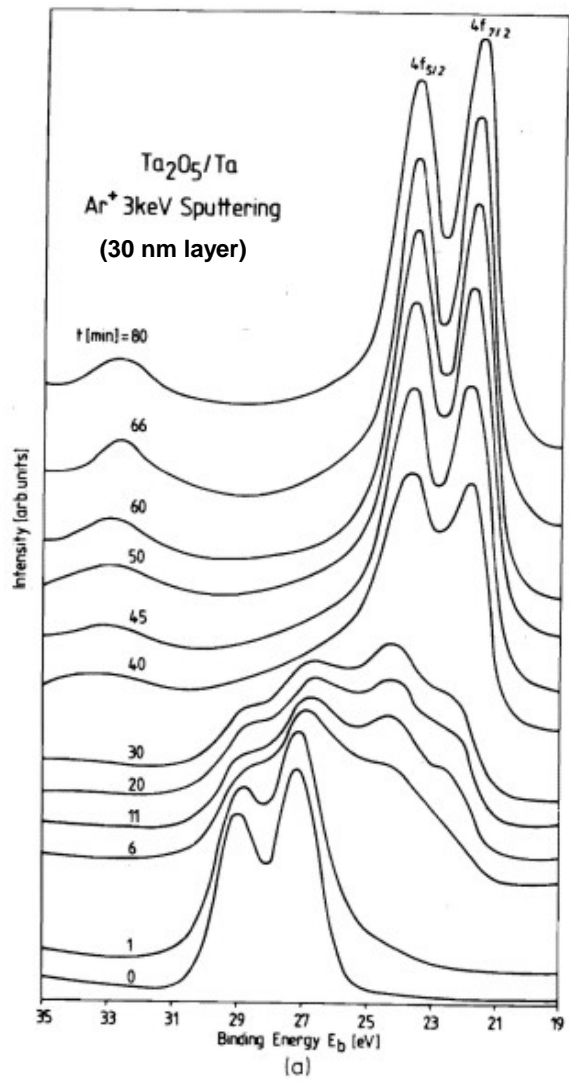
Au on GaN (Au 4f peaks)
Increasing Au coverage (from a to d)



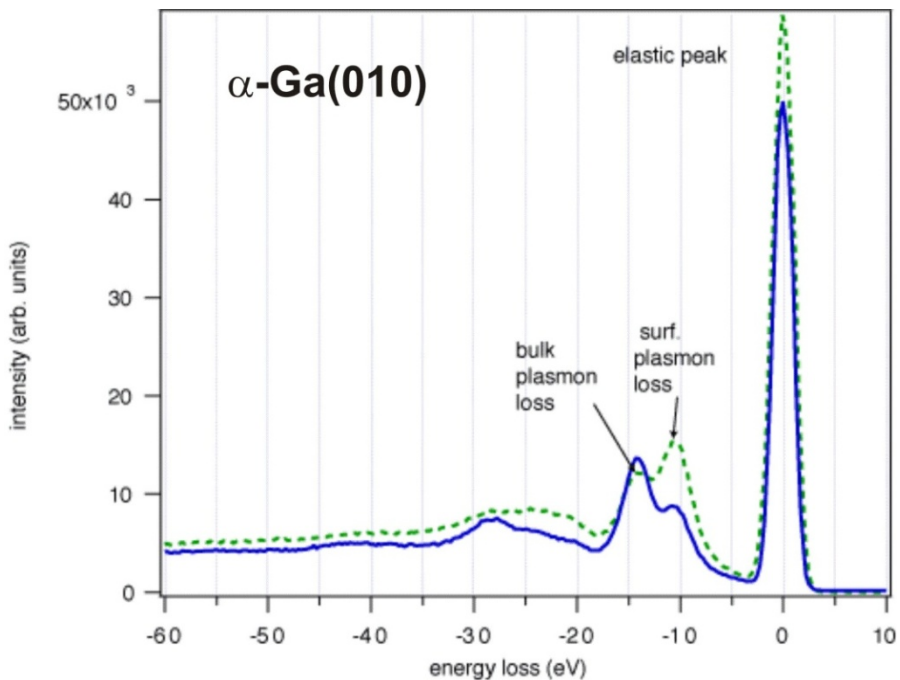
R. Sporken et al.

Depth profiling

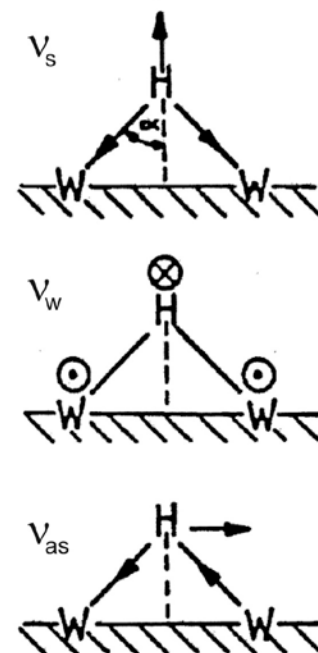
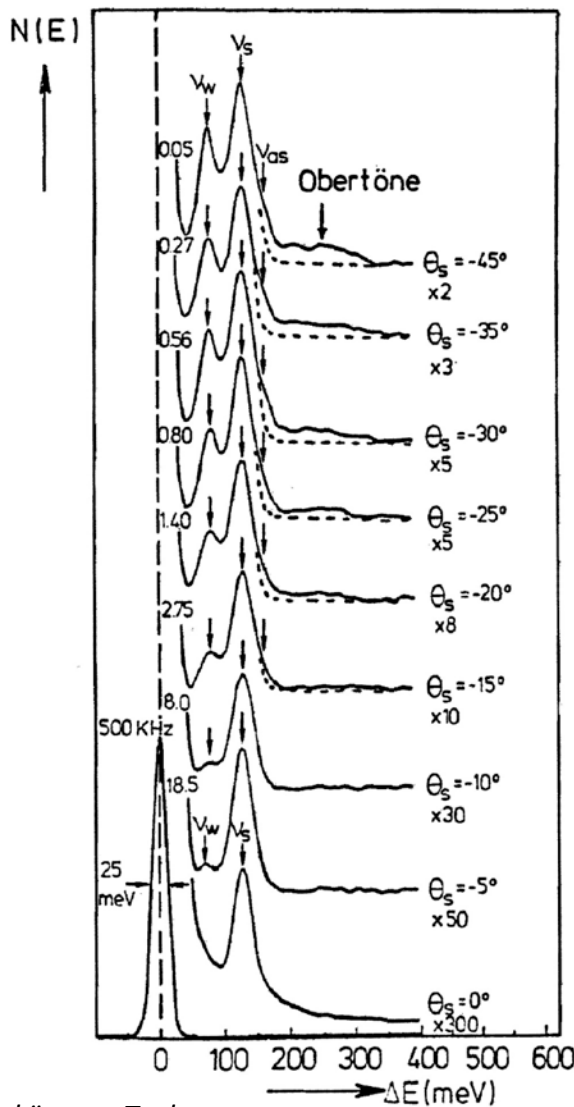
Sputtering during AES analysis



Different geometries



P. Hofmann (Univ. Aarhus)



Henzler/Göpel: Oberflächenphysik des Festkörpers, Teubner

Tab. 4.1 Atommassen einiger wichtiger Elemente, deren natürliche Isotope mit natürlicher Häufigkeit und exakten Massen, sowie Klassifizierung¹

Element	Atommasse	nominale Masse	Isotopen	rel. Häufigkeit (%)	isotopische Massen	Klassifizierung
H	1.00794	1	¹ H	99.985	1.007825	X
			² H = D	0.015	2.0141102	X + 1
Li	6.941	7	⁶ Li	7.5	6.015123	X - 1
			⁷ Li	92.5	7.016005	X
B	10.811	11	¹⁰ B	19.9	10.012938	X - 1
			¹¹ B	80.1	11.009305	X
C	12.011	12	¹² C	98.90	12.000000	X
			¹³ C	1.10	13.003355	X + 1
N	14.00674	14	¹⁴ N	99.634	14.003074	X
			¹⁵ N	0.366	15.000109	X + 1
O	15.9994	16	¹⁶ O	99.762	15.994915	X
			¹⁷ O	0.038	16.999131	X + 1
			¹⁸ O	0.200	17.999159	X + 2
F	18.998403	19	¹⁹ F	100	18.998403	X
Na	22.989768	23	²³ Na	100	22.989770	X
Si	28.0855	28	²⁸ Si	92.23	27.976928	X
			²⁹ Si	4.67	28.976496	X + 1
			³⁰ Si	3.10	29.973772	X + 2
P	30.973762	31	³¹ P	100	30.973763	X
S	32.066	32	³² S	95.02	31.972072	X
			³³ S	0.75	32.971459	X + 1
			³⁴ S	4.21	33.967868	X + 2
			³⁵ S	0.02	35.967079	X + 3
Cl	35.4527	35	³⁵ Cl	75.77	34.968853	X
			³⁷ Cl	24.23	36.965903	X + 2
Ar	39.948	40	³⁶ Ar	0.337	35.967546	X - 4
			³⁸ Ar	0.063	37.962732	X - 2
			⁴⁰ Ar	99.600	39.962383	X
Fe	55.847	56	⁵⁴ Fe	5.8	53.939612	X - 2
			⁵⁶ Fe	91.72	55.934939	X
			⁵⁷ Fe	2.2	56.935396	X + 1
			⁵⁸ Fe	0.28	57.933278	X + 2

Source: *Spektroskopische Methoden in der organischen Chemie, Hesse/Meier/Zeeh*

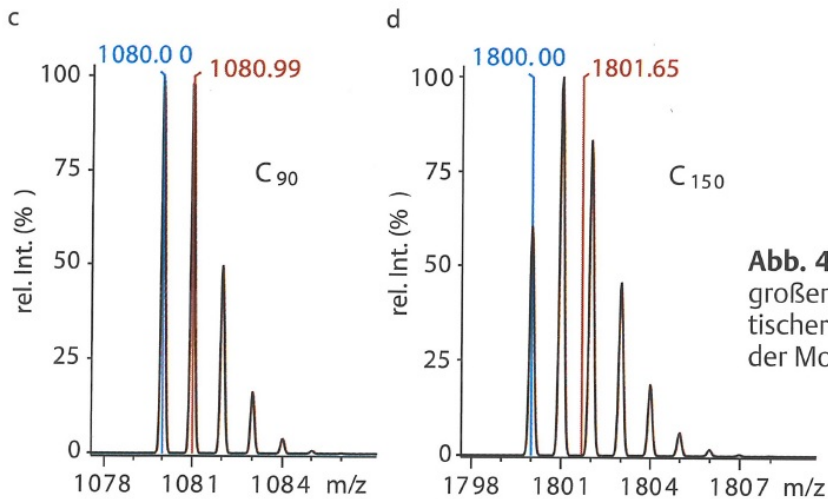
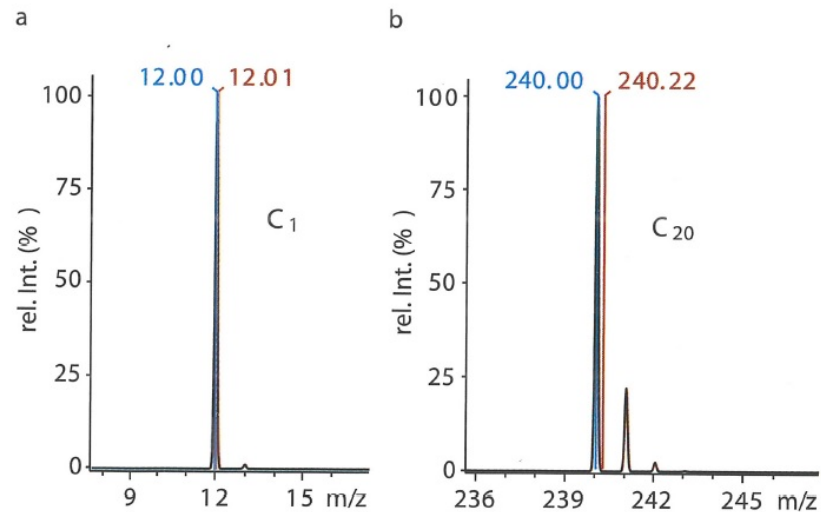


Abb. 4.8 Einfluss der Anzahl C-Atome auf die Isotopenverteilung bei großen Molekülen anhand der berechneten $M^{+•}$ Spektren hypothetischer C_n -Verbindungen (blau: monoisotopische Masse, rot: Lage der Molmasse (M_R))

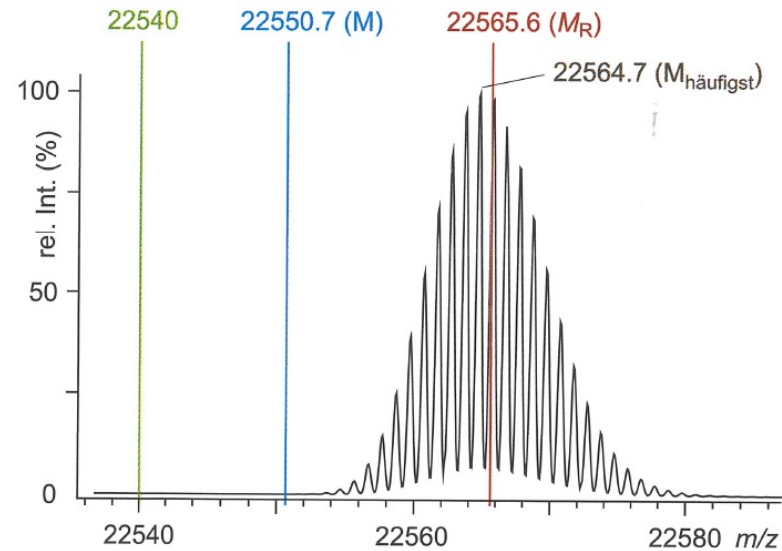


Abb. 4.9 Berechnete Isotopenverteilung für das Ion eines hypothetischen Biopolymers (Peptid) mit der Summenformel $C_{1000}H_{1500}N_{280}O_{290}S_{15}$ (blau: monoisotopische Masse (M), rot: Molmasse (M_R) die ungefähr der häufigsten Masse ($M_{\text{häufigst}}$) entspricht, grün: Nominalmasse)

Source: Spektroskopische Methoden in der organischen Chemie, Hesse/Meier/Zeeh

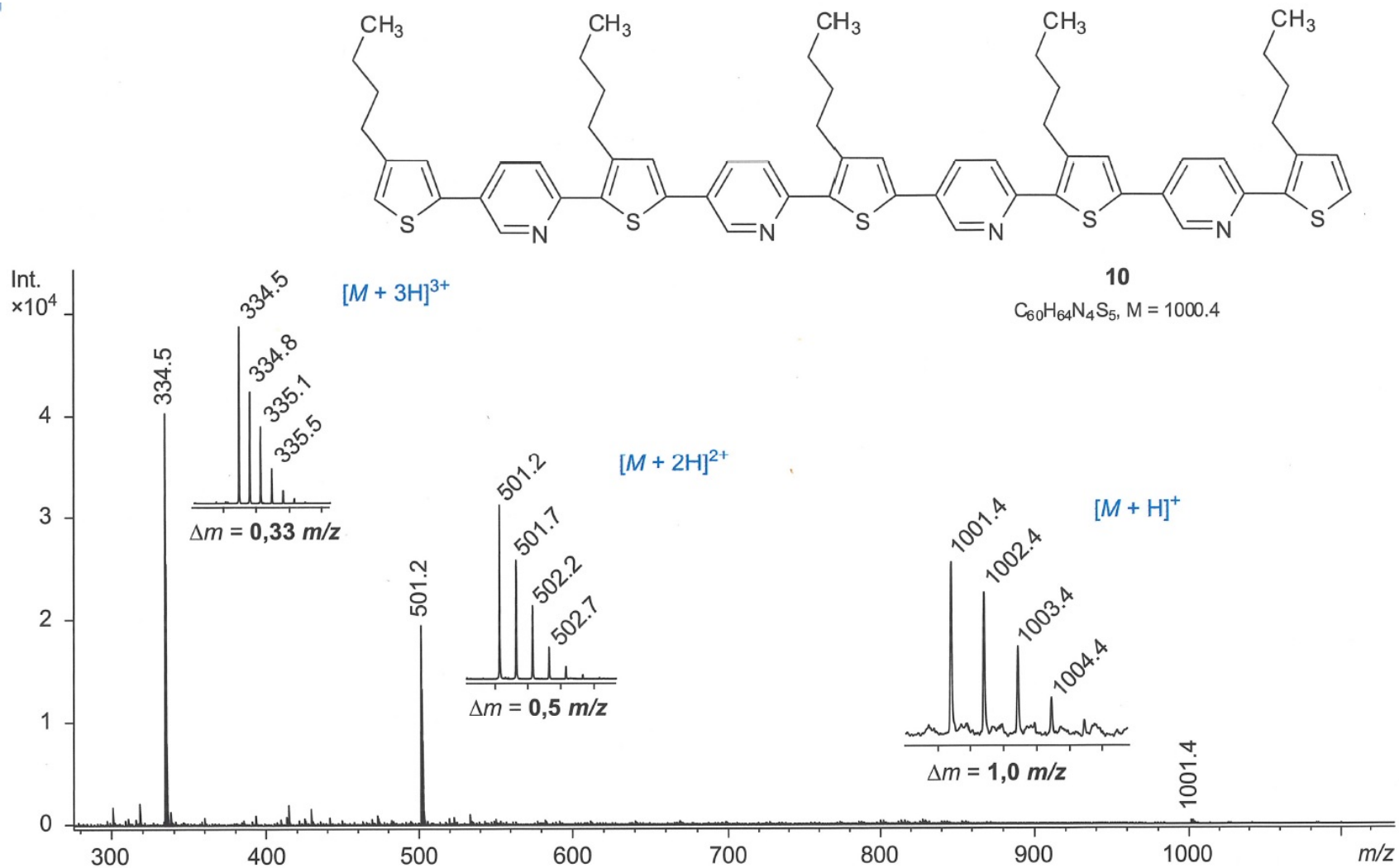
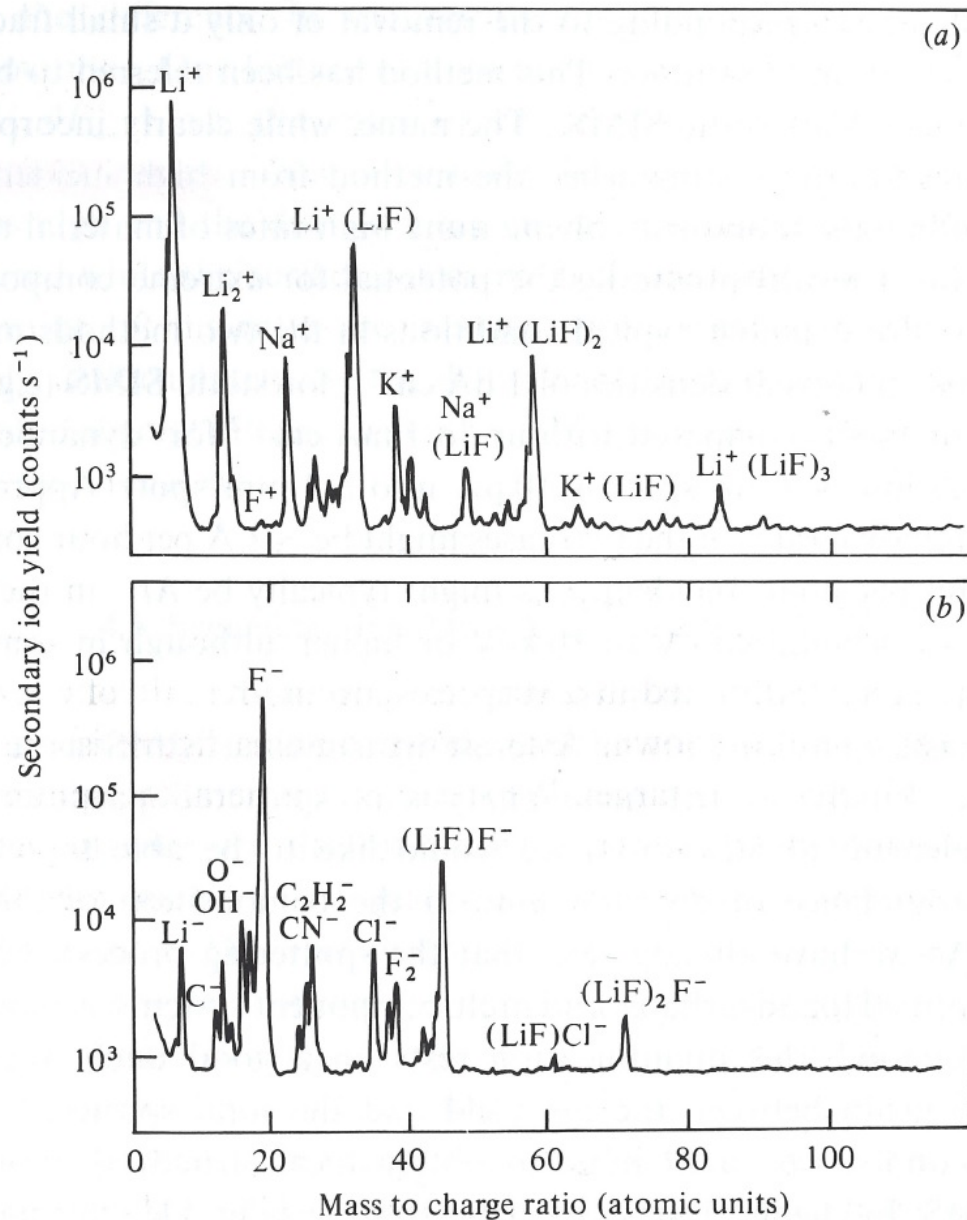


Abb. 4.10 ESI-MS der Verbindung **10** mit Signalen für Ionen des Typs $[M + H]^+$, $[M + 2H]^{2+}$ und $[M + 3H]^{3+}$ (Probe von N. Finney, Universität Zürich)

Source: *Spektroskopische Methoden in der organischen Chemie*, Hesse/Meier/Zeeh



Source: *Modern Techniques of Surface Science*,
2nd edition
Woodruff & Delchar

Fig. 4.47 Positive (a) and negative (b) SIMS spectra from a LiF{100} surface using 1.3 keV Ar⁺ ions incident at 60° (after Estel *et al.*, 1976).